

Fast CXRS Measurements at the Pedestal

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Thanks to: R. Dux¹, C. Maggi¹, A. Whiteford² and the ASDEX Upgrade Team

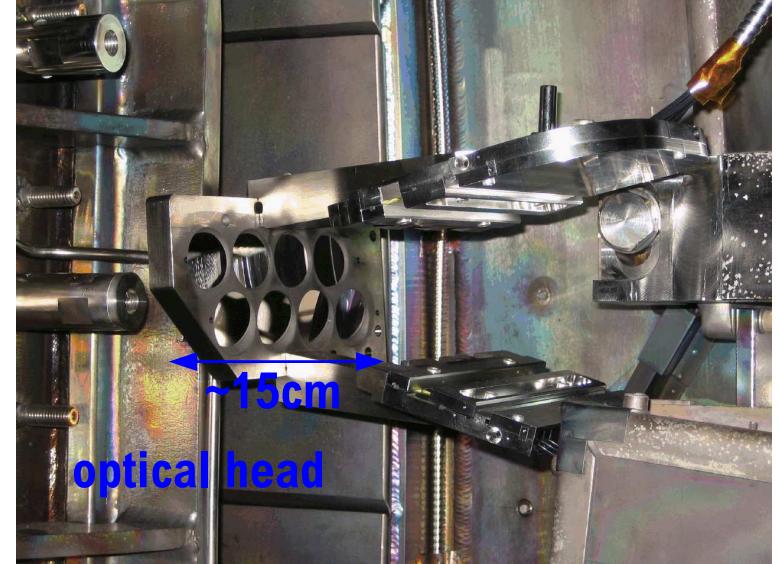
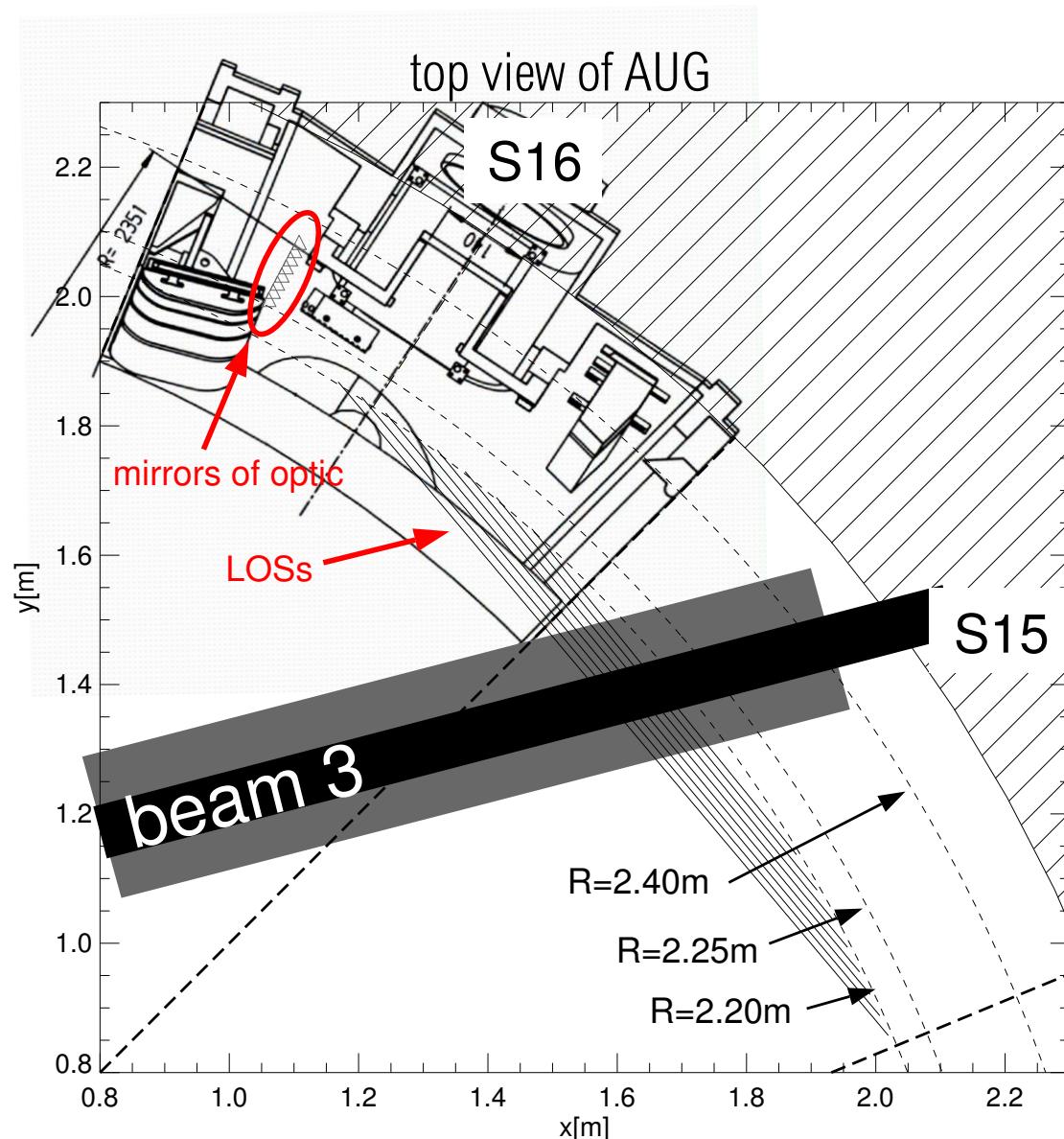
1) IPP, Garching

2) University of Strathclyde, Glasgow

- Why and how?
- Hardware and geometry of new edge-CXRS system at AUG
- first measurements on He, C, Ne
- ELM-cycle resolution
- Outlook

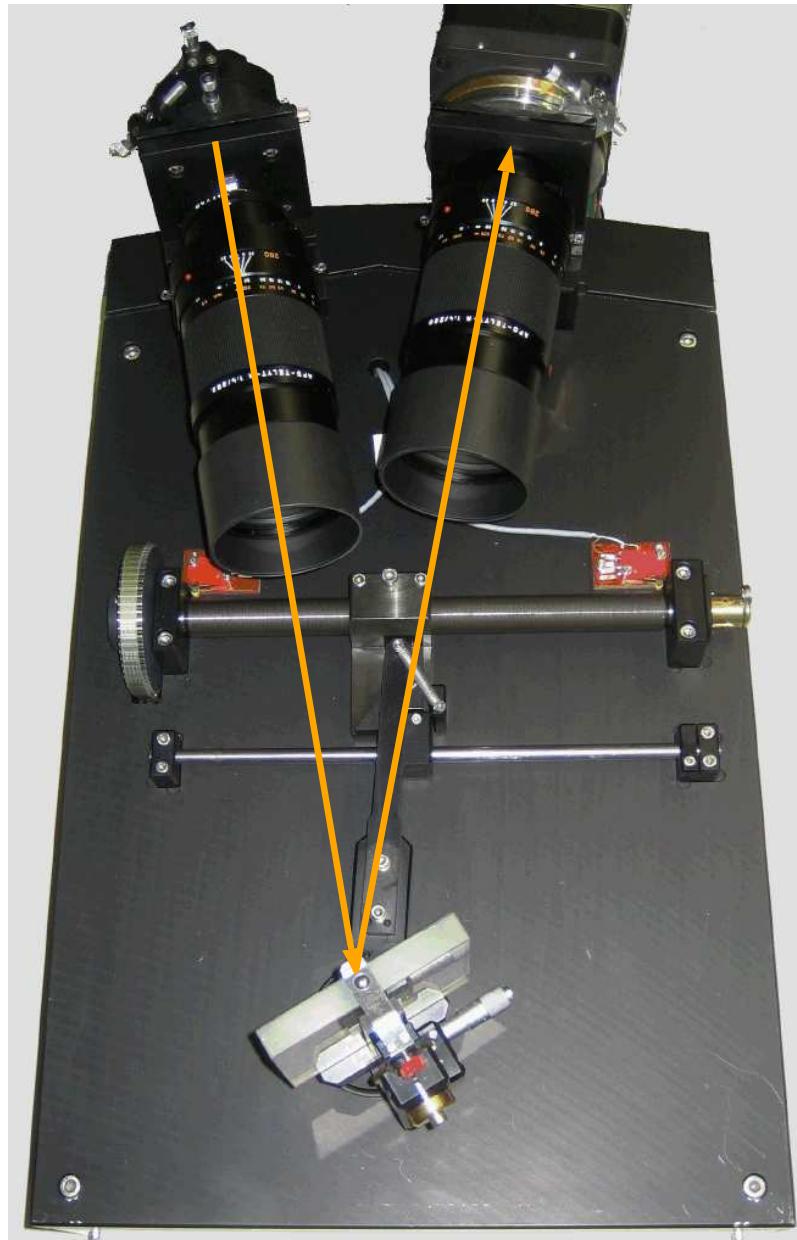
- Pedestal pressure important for total confinement
- Toroidal rotation interesting for H-mode theories
- Impurity transport at pedestal defines impurity content of plasma
- Fast necessary, because of fast phenomena at edge (ELMs, transport)
- Spatial resolution, because of steep gradients at the edge

Geometry of the New Edge-CXRS System



- high spatial resolution implies delicate alignment of LOS
- f/4 optics for high throughput
- plasma is observed at $0.9 < \rho_{pol} < 1.05$

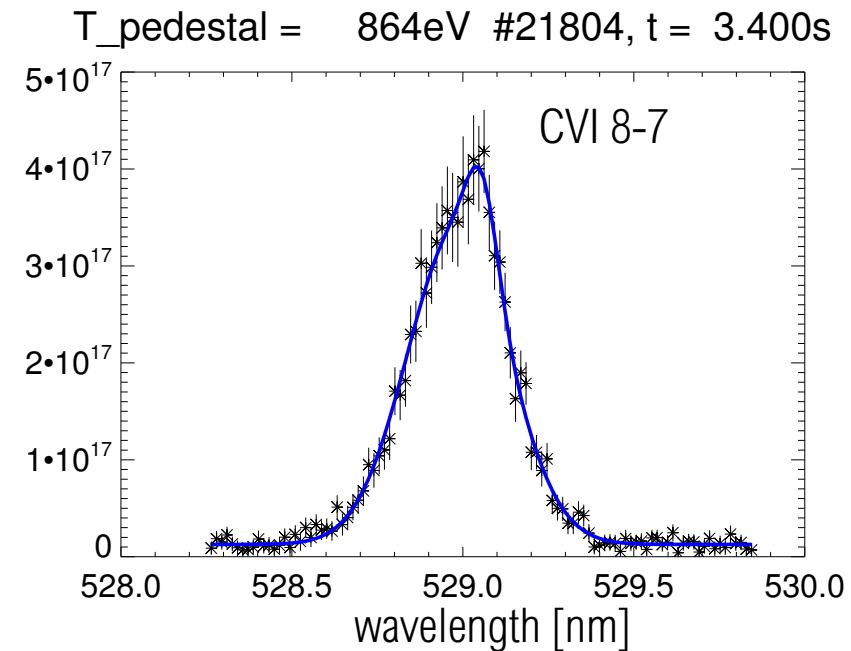
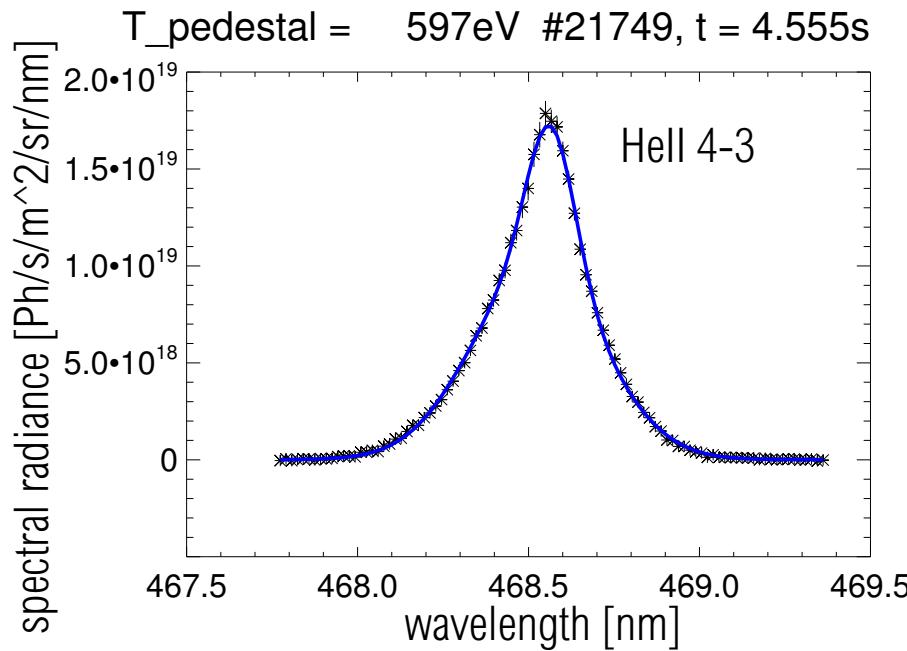
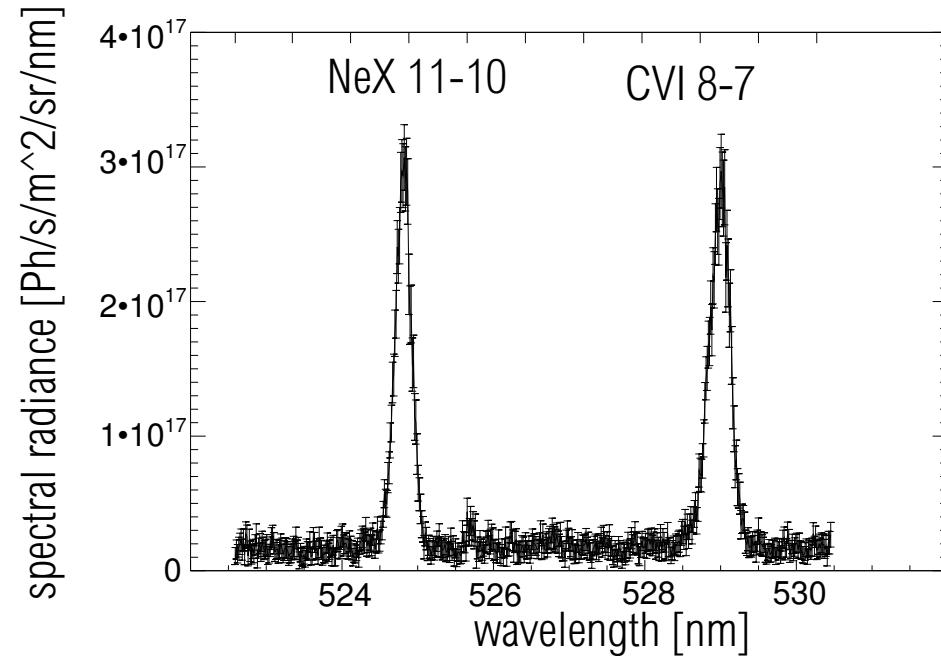
Spectrometer of the New Edge-CXRS System



- f/4 optics, 280 mm focal length
- high-quality imaging → 15 channels can be measured
- 1.9 ms repetition time standard - down to 250 μ s possible for single channel
- back-illuminated EMCCD (high QE, fast readout (10 MHz) with increased signal/noise)

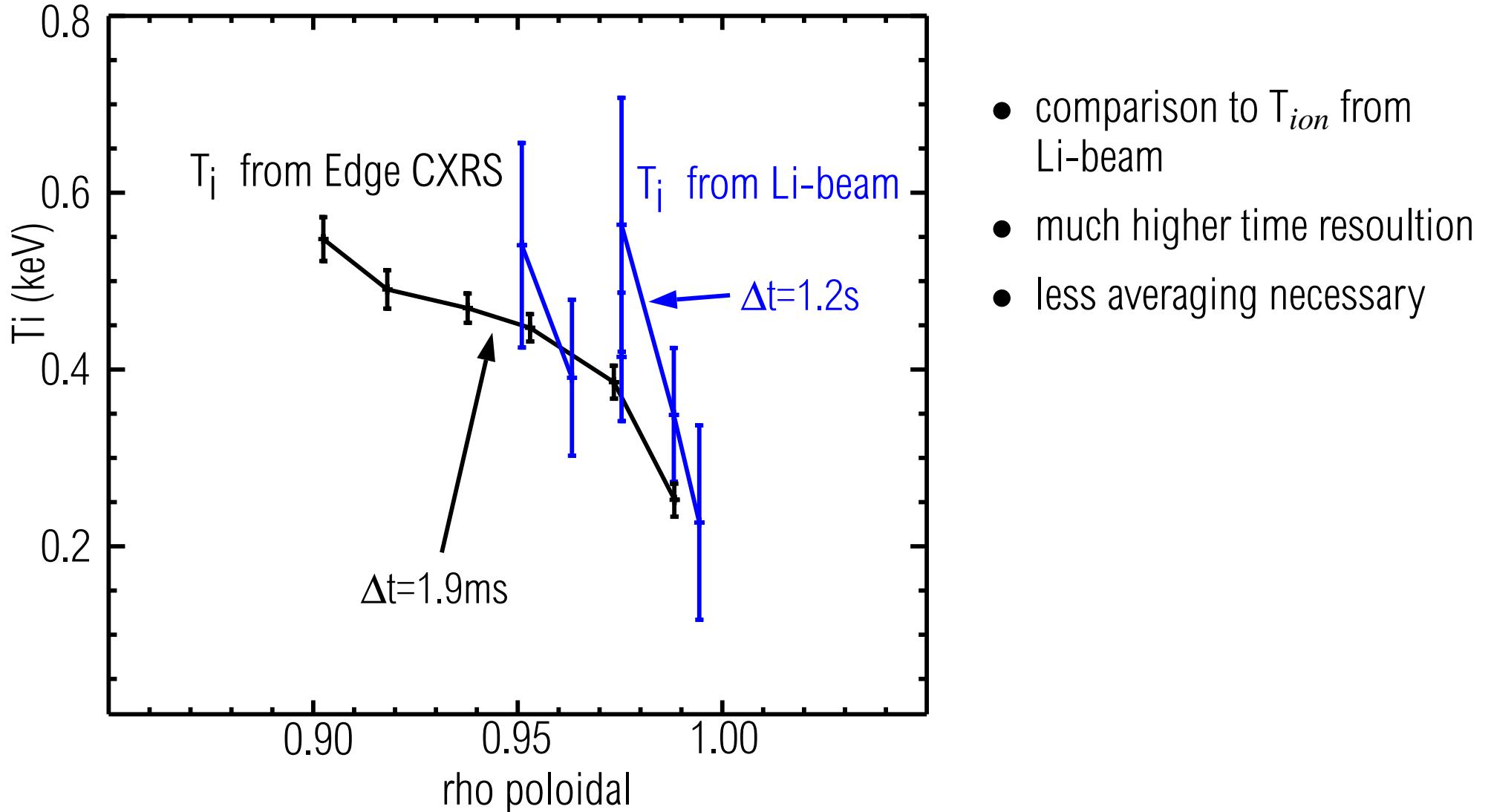
Spectra for He, C and Ne

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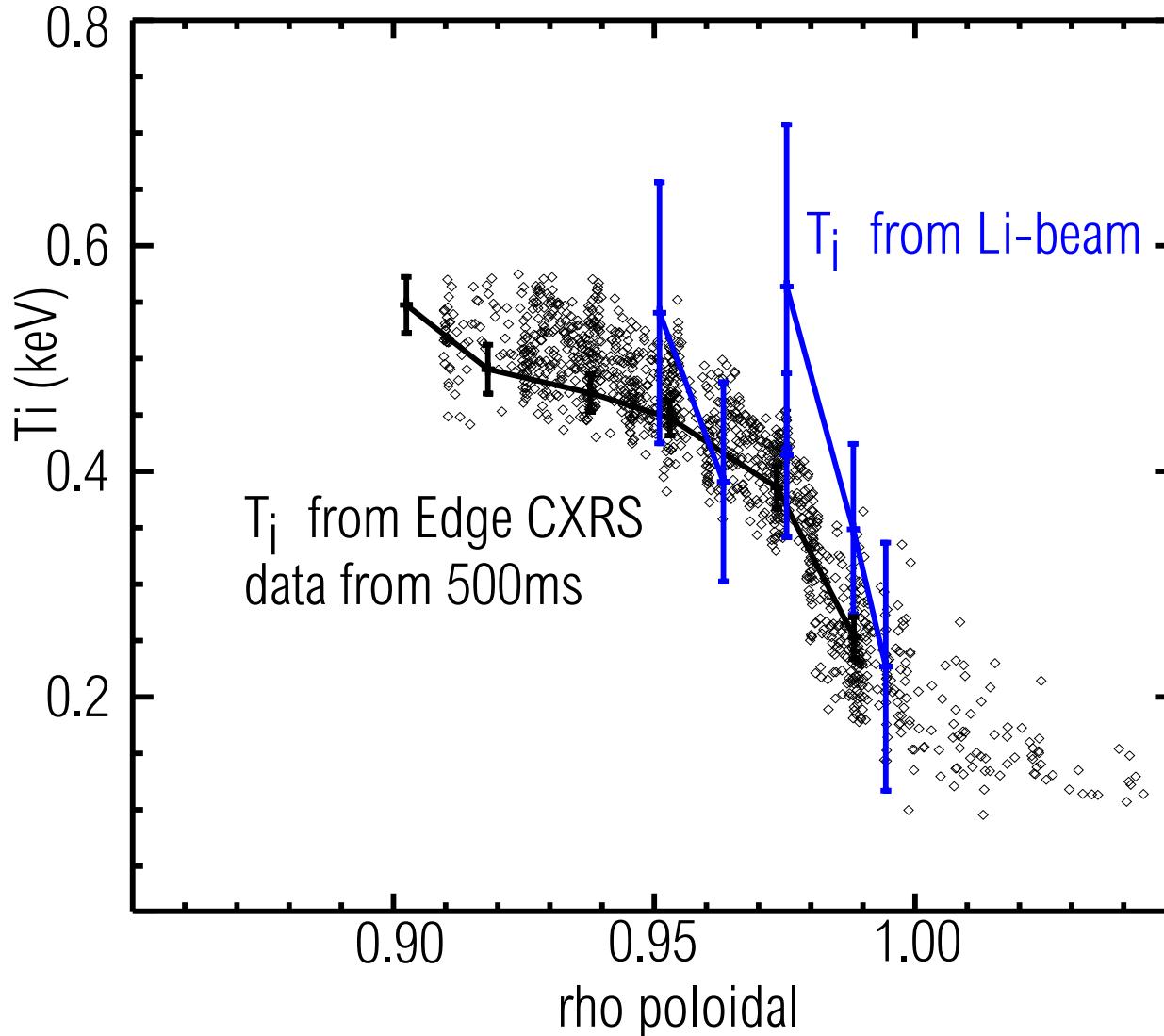
T_{ion} profiles

IPP

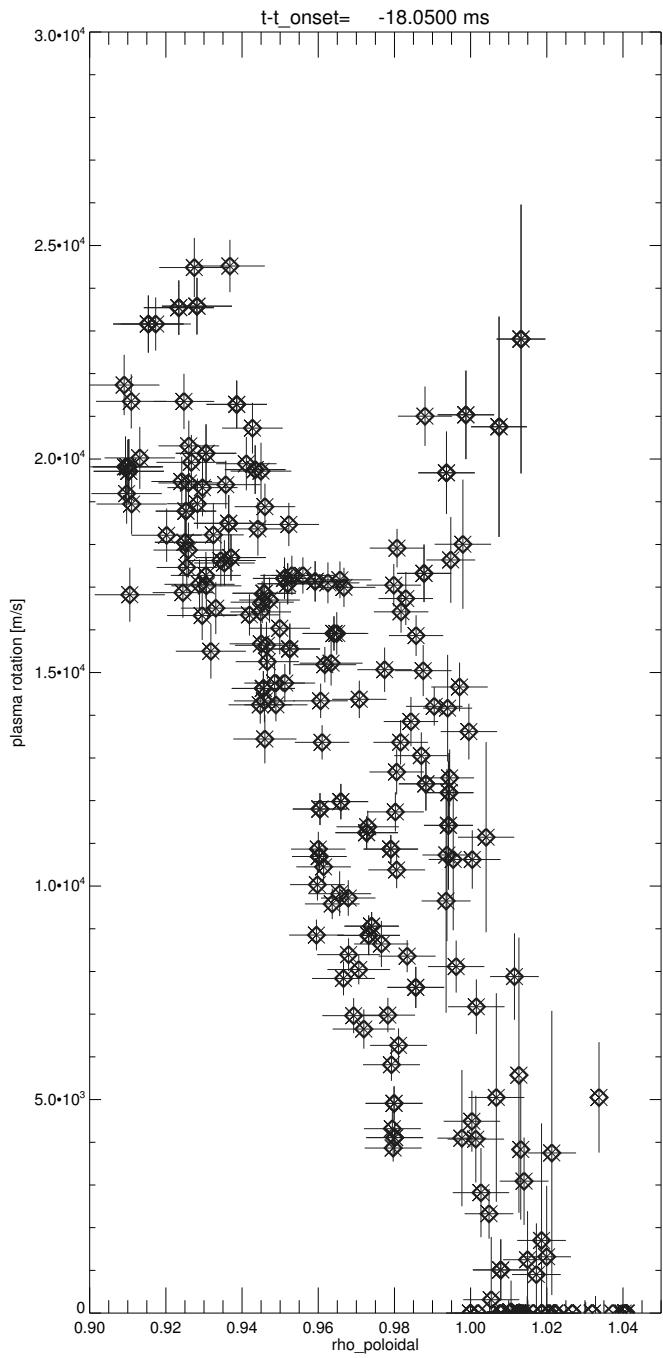
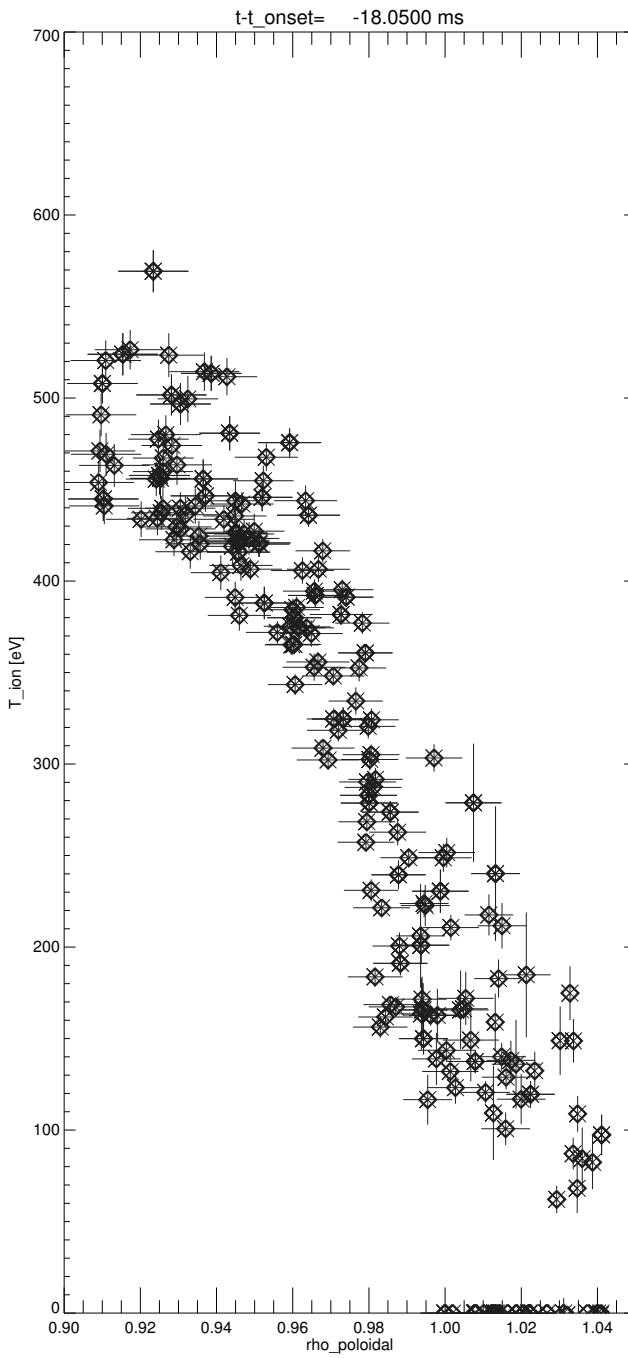
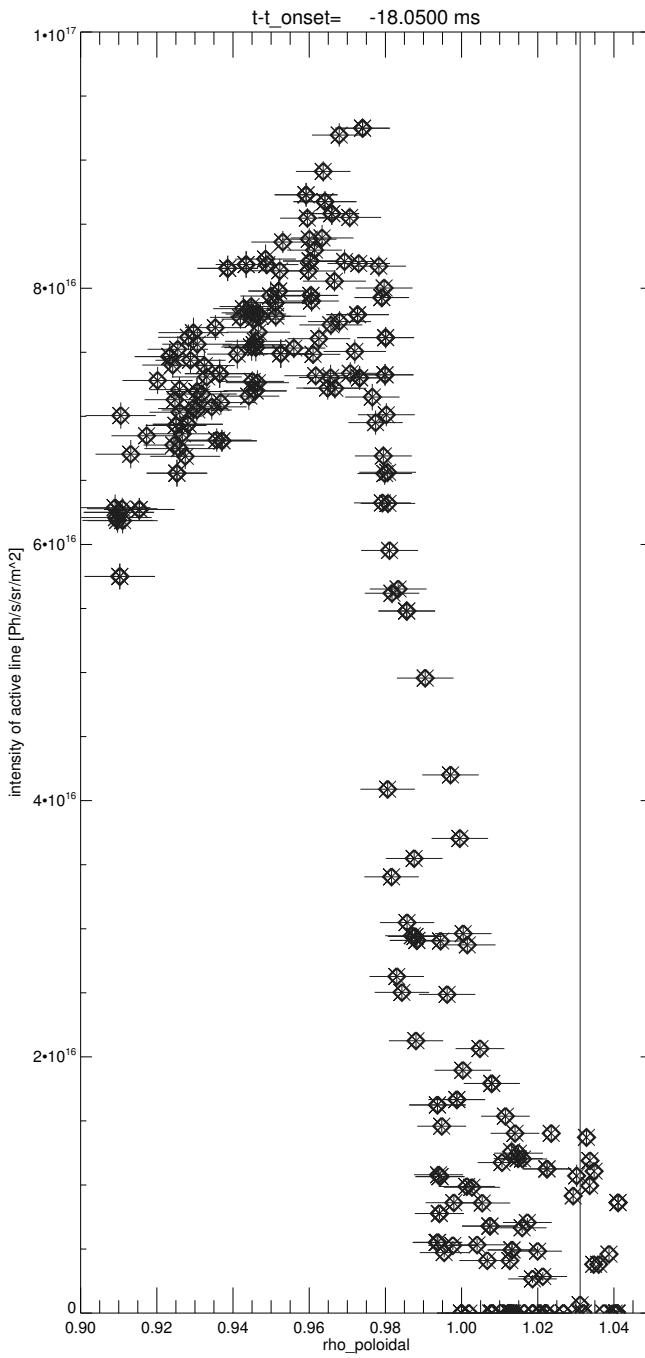


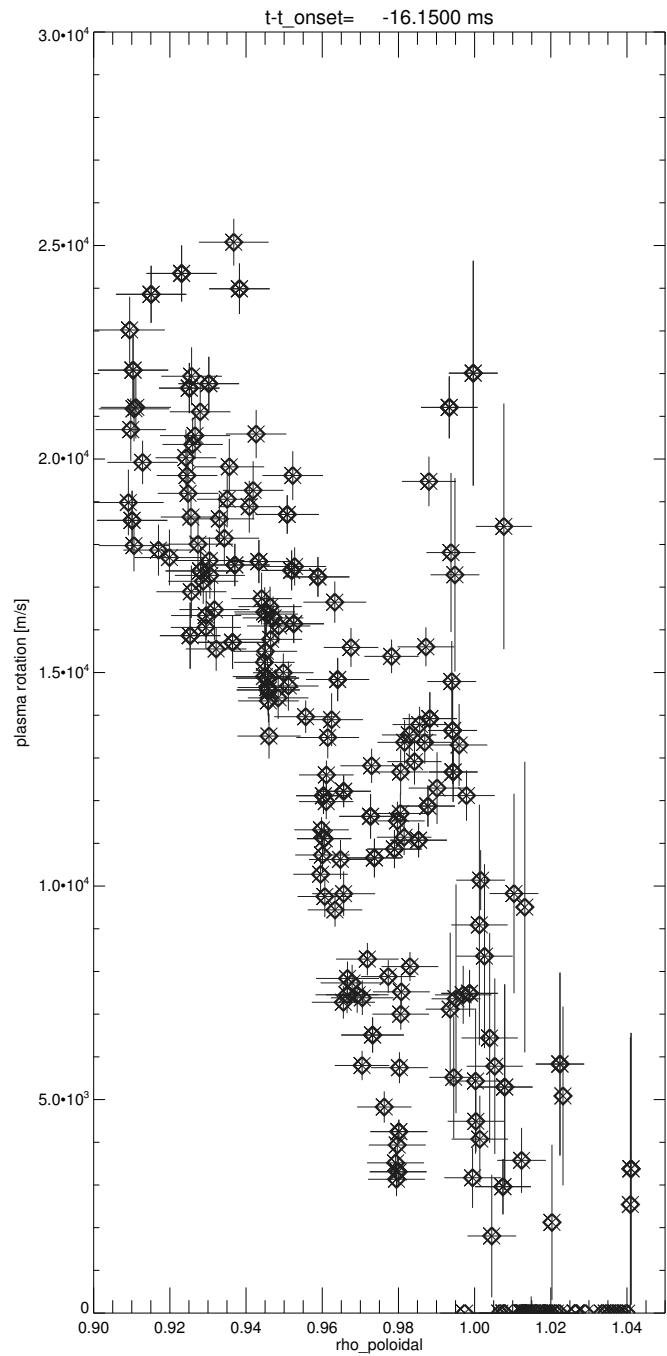
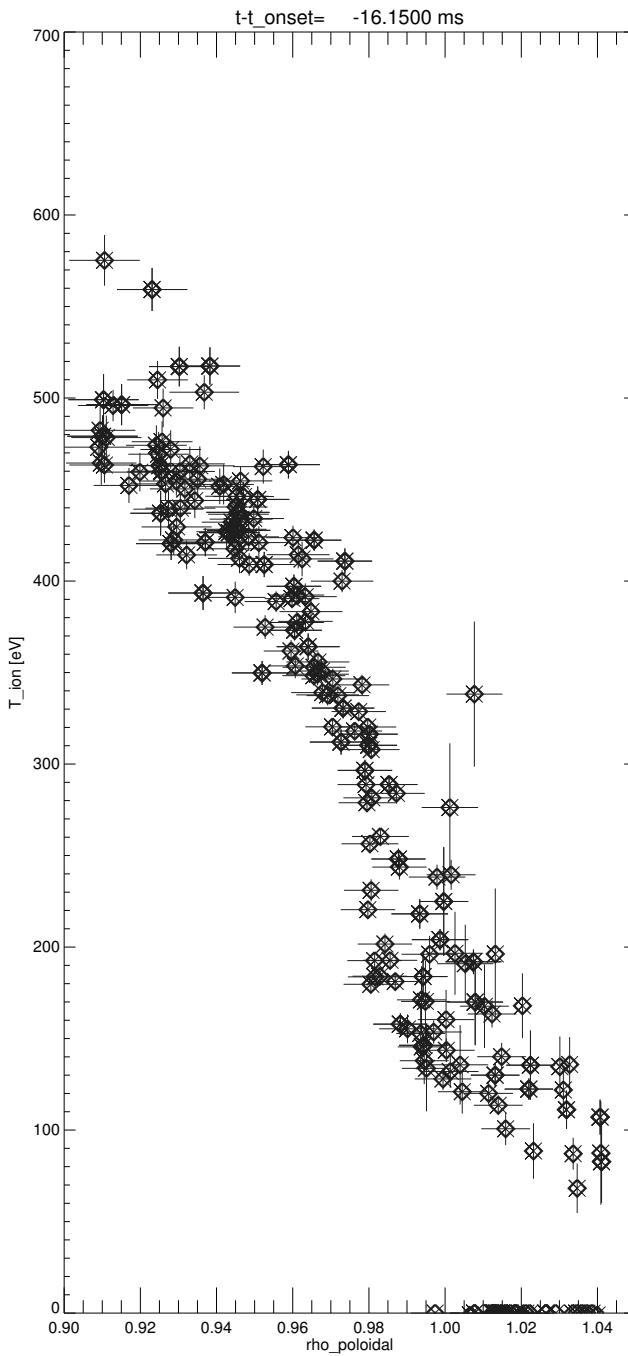
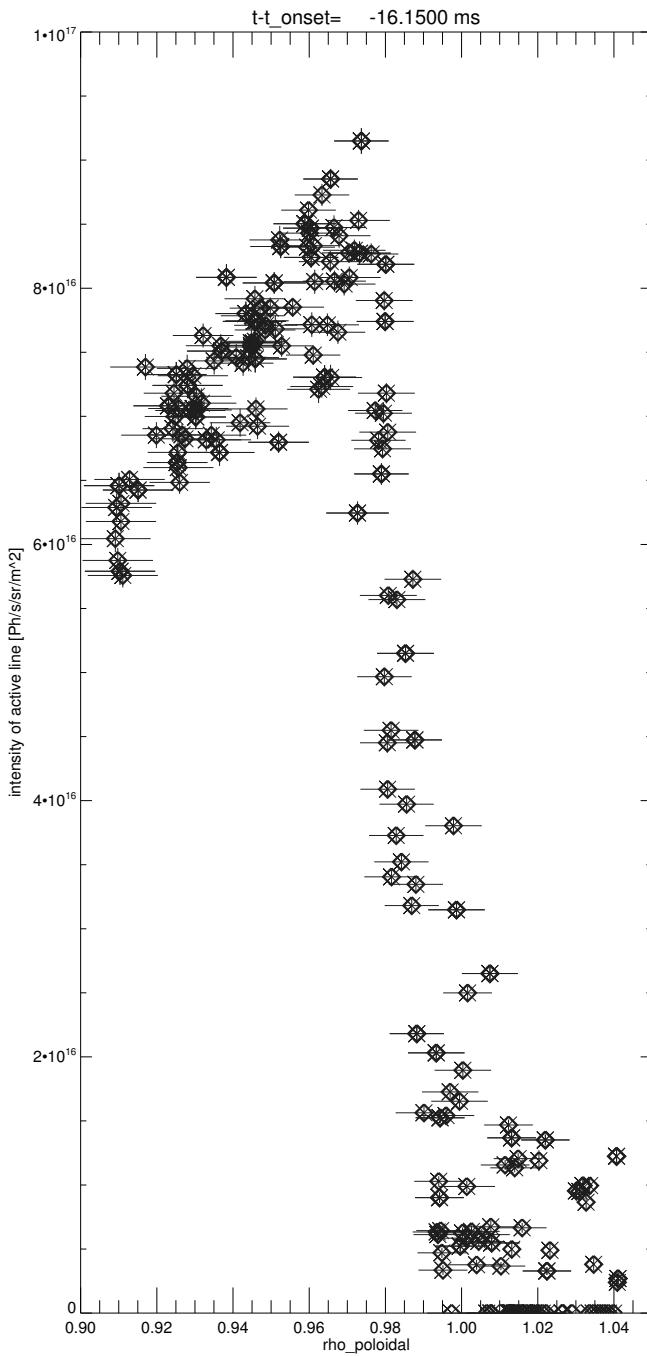
T_{ion} profiles

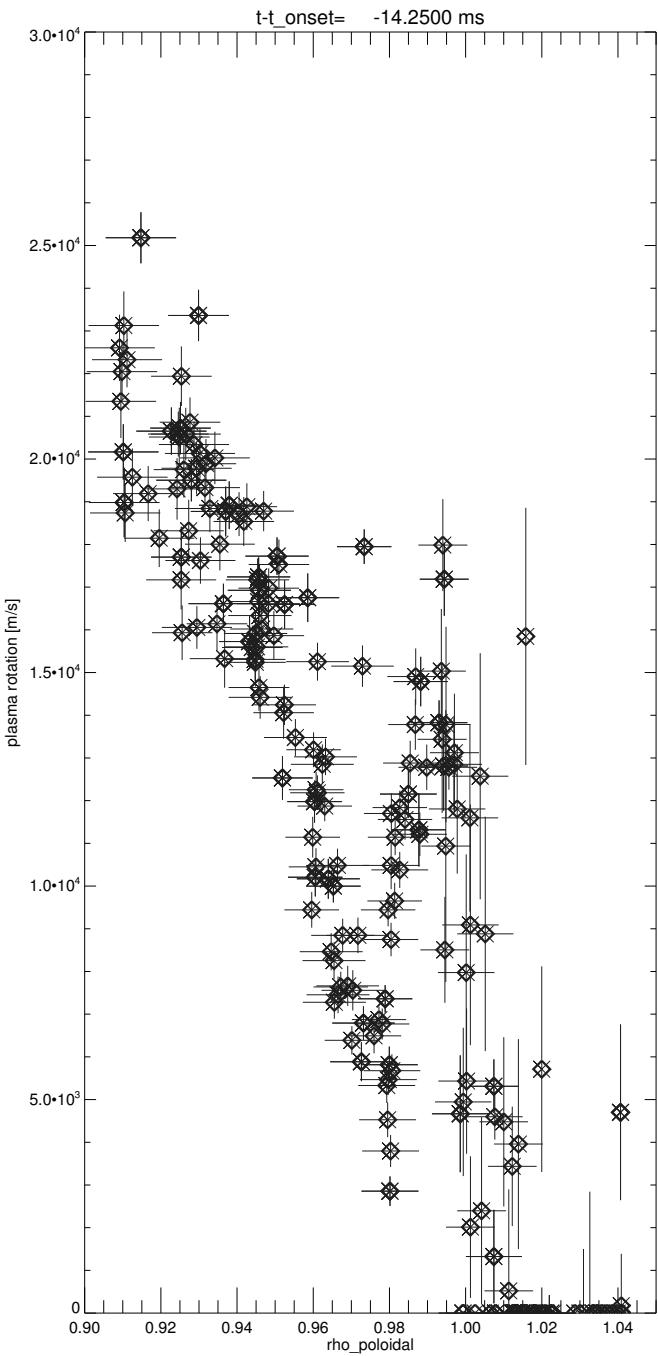
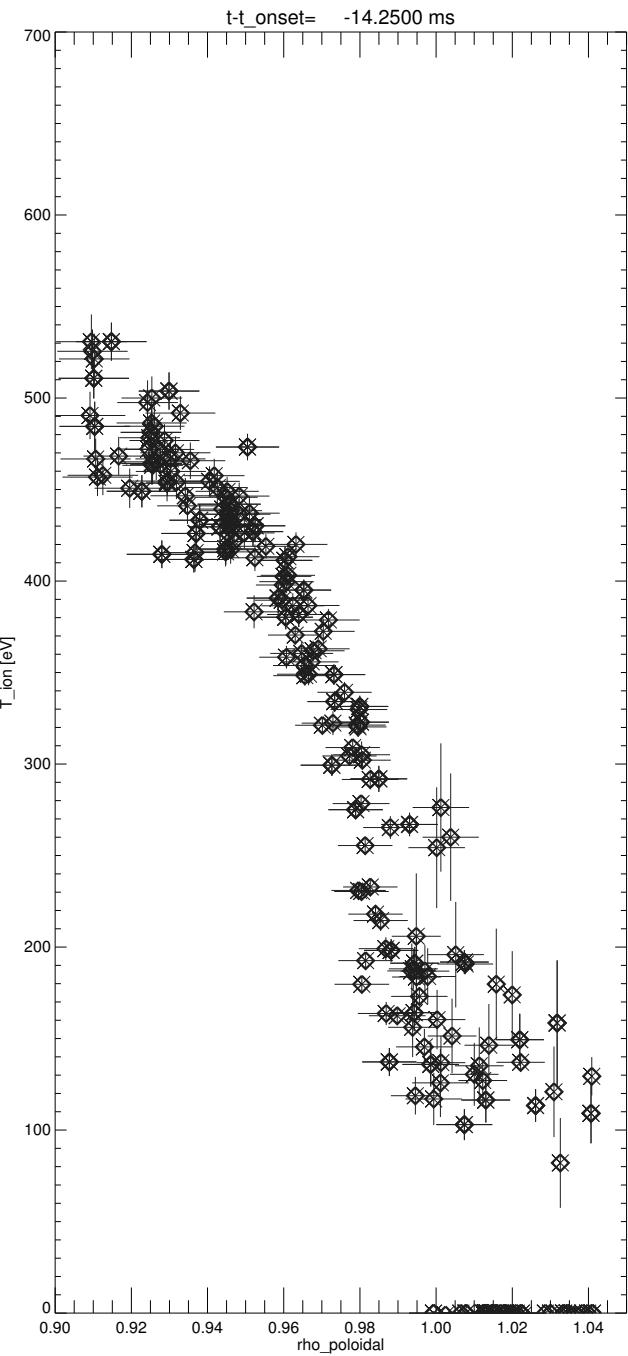
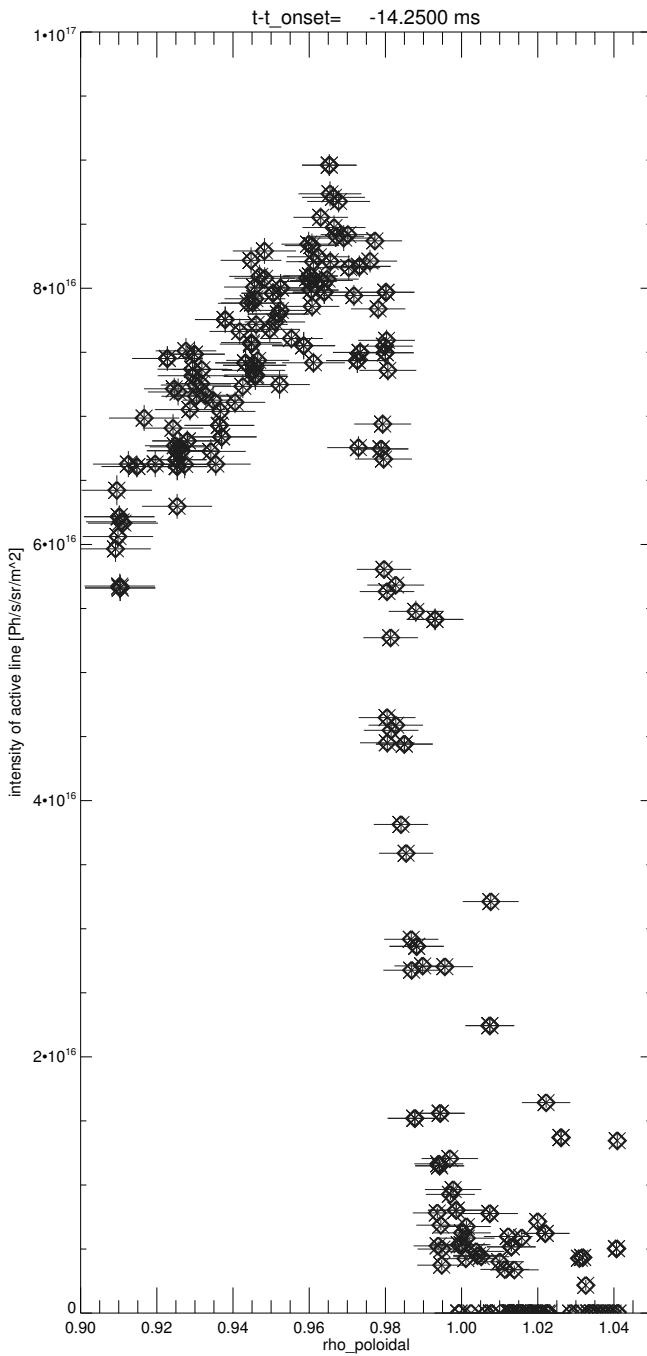
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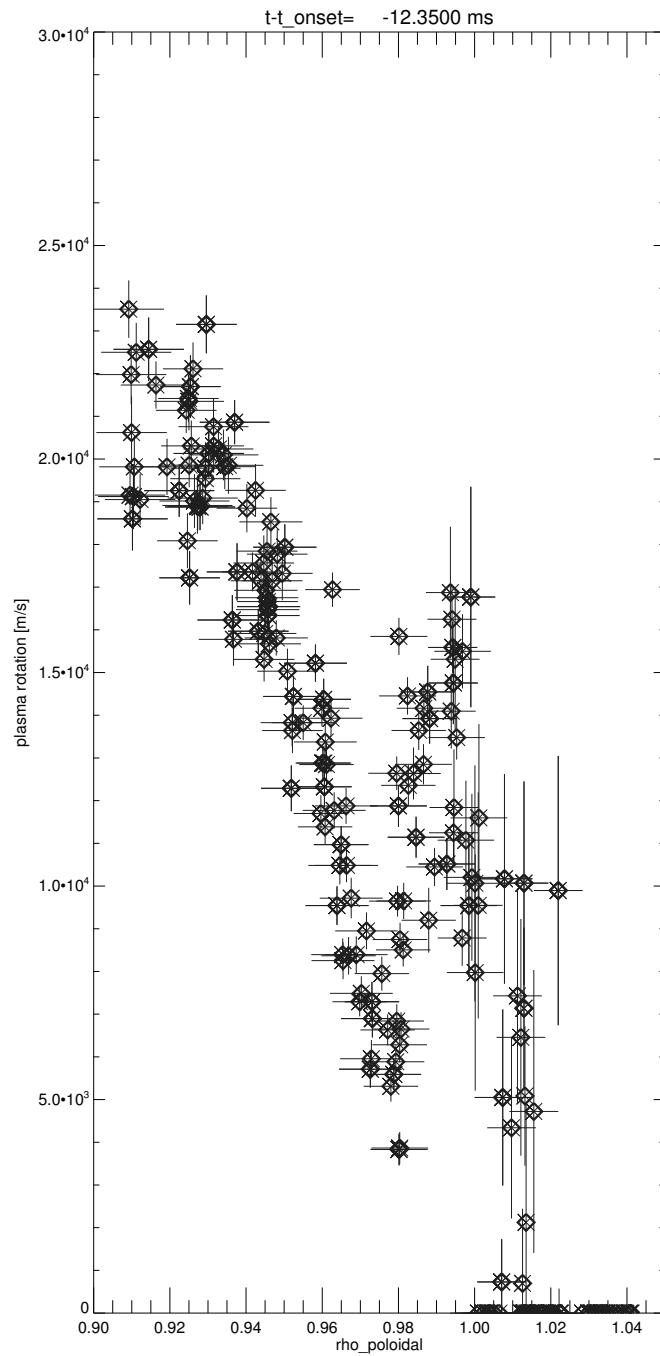
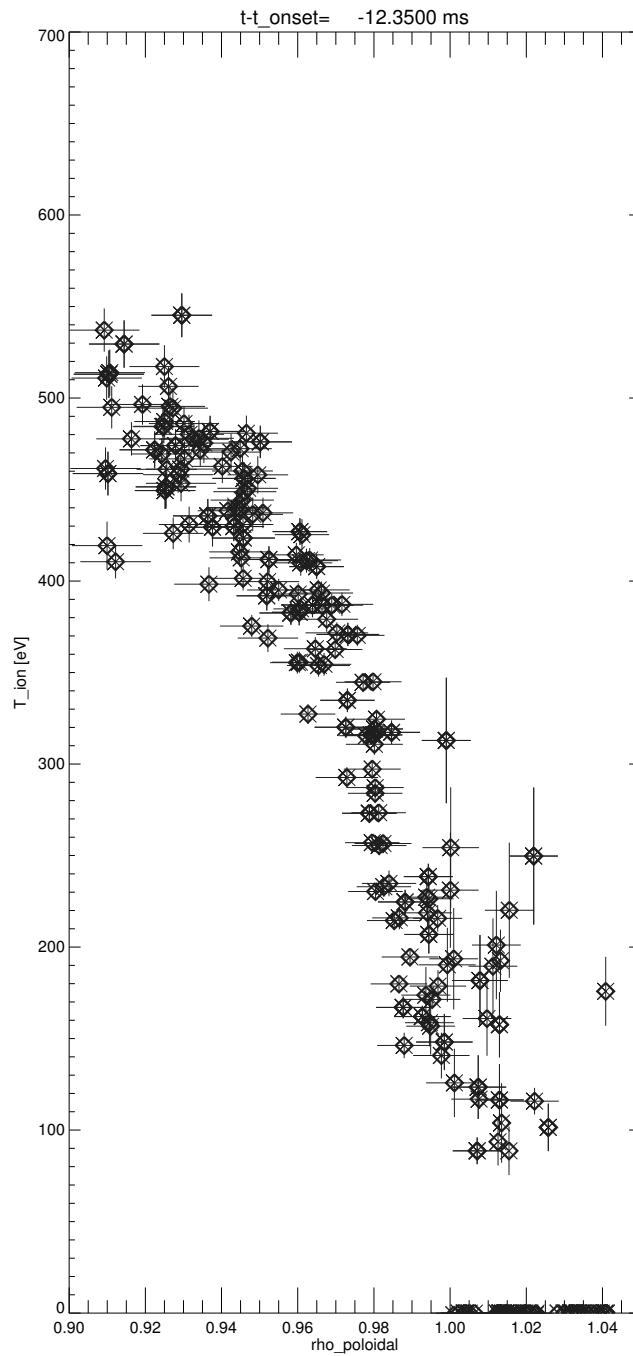
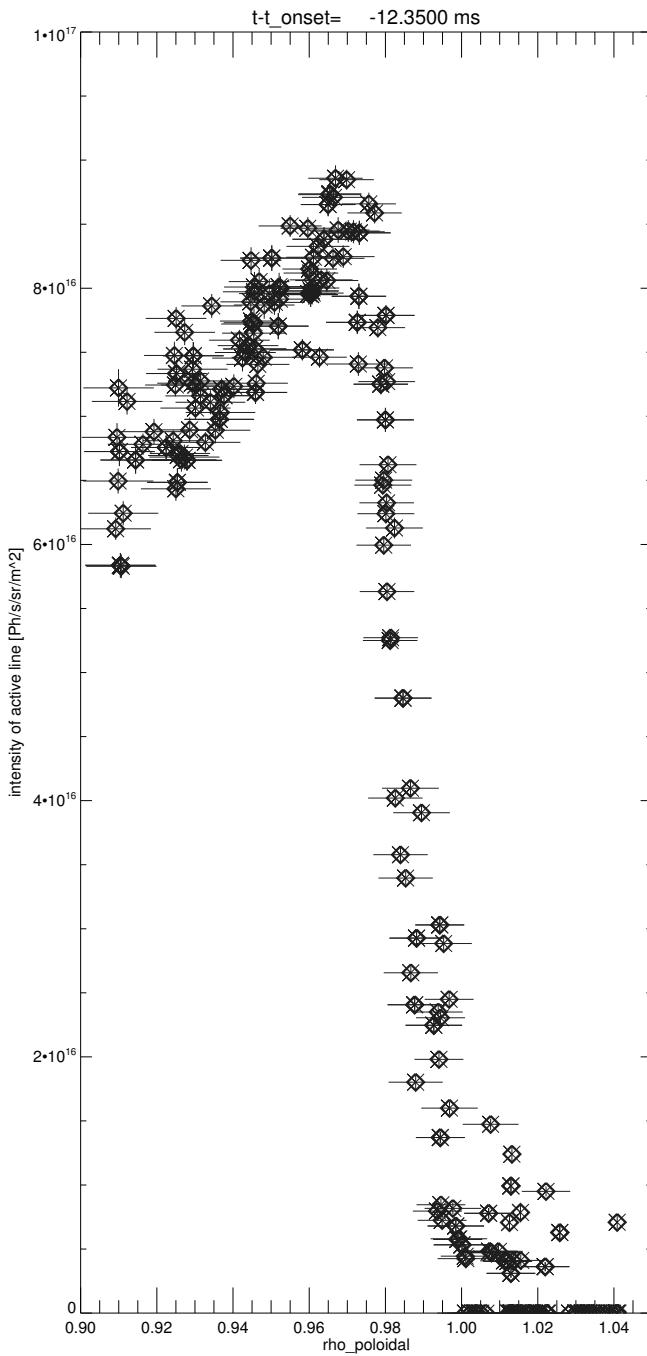


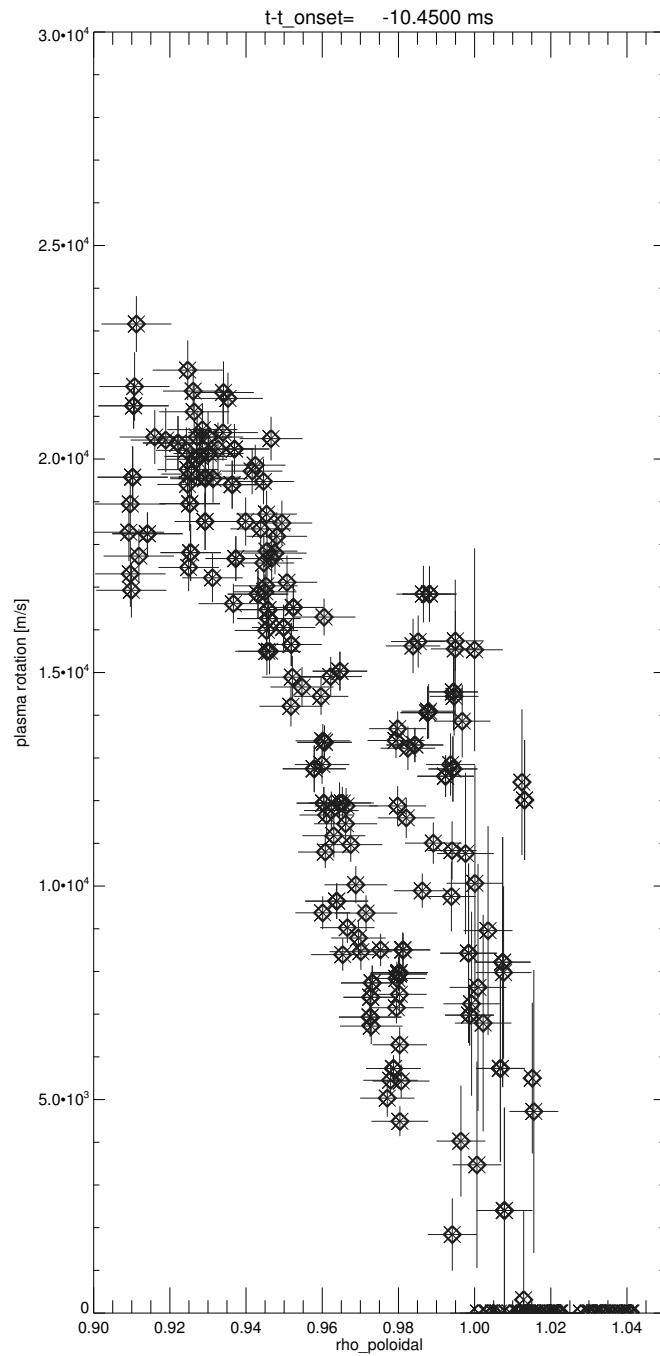
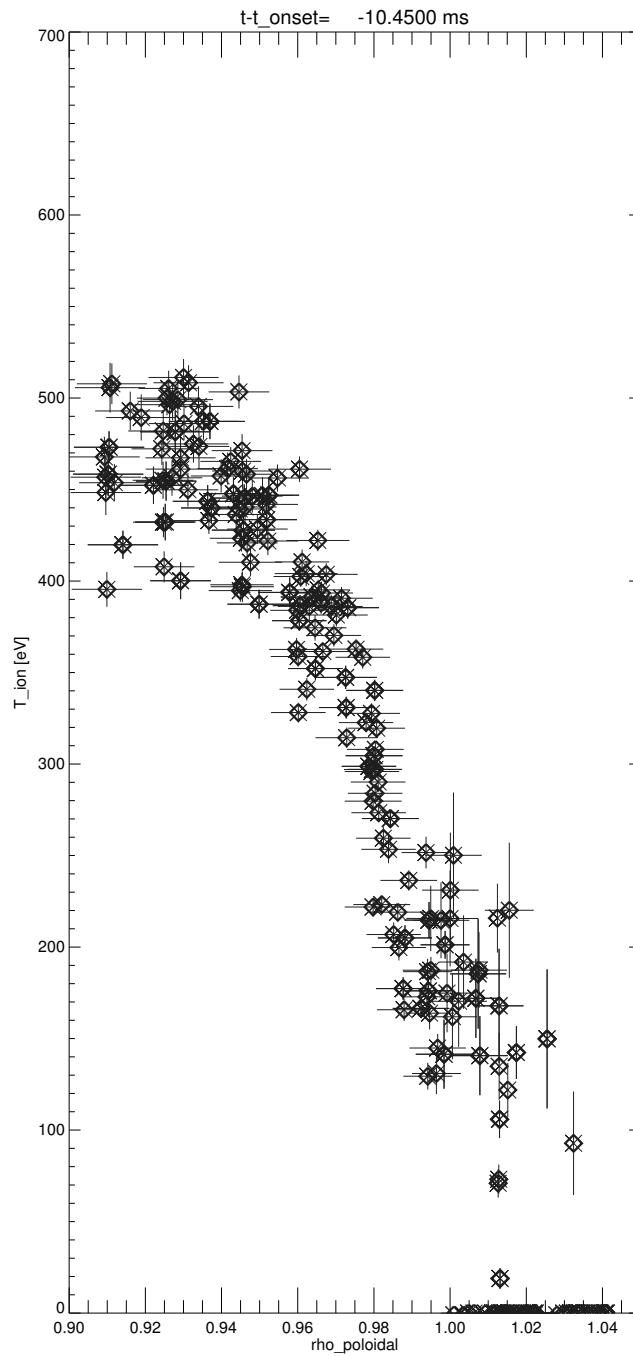
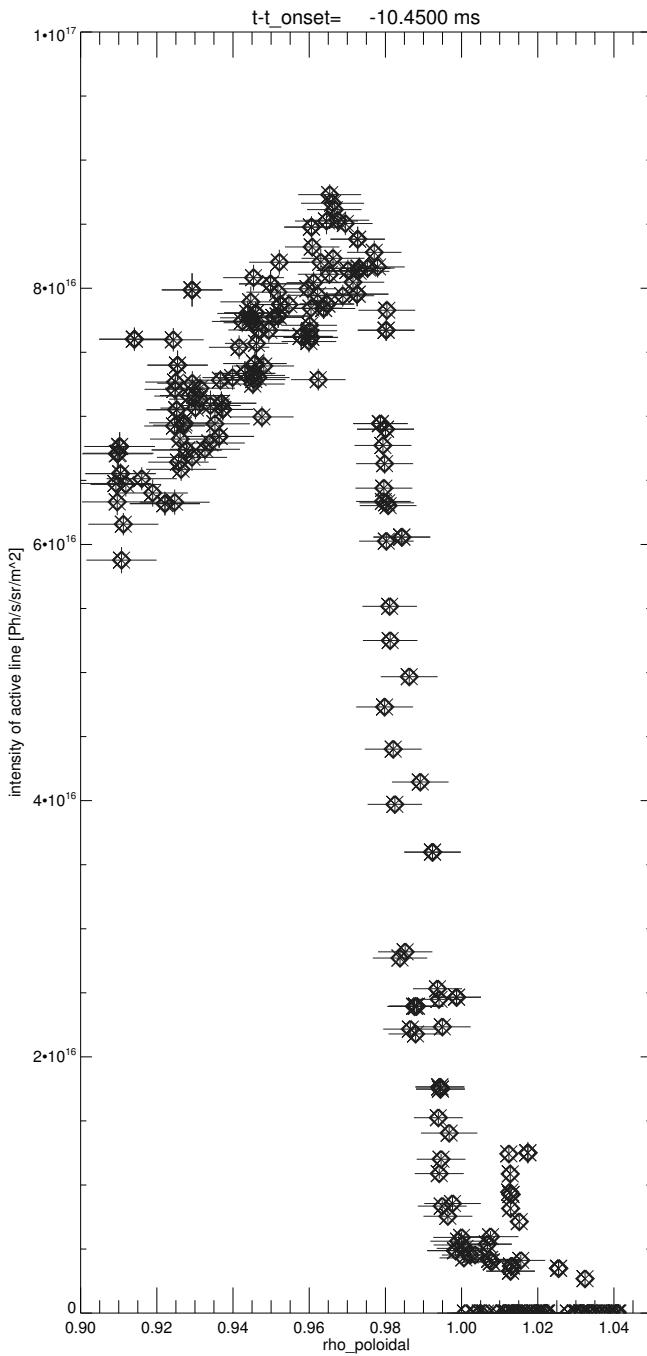
- comparison to T_{ion} from Li-beam
- much higher time resolution
- less averaging necessary
- movement of plasma increases spatial resolution

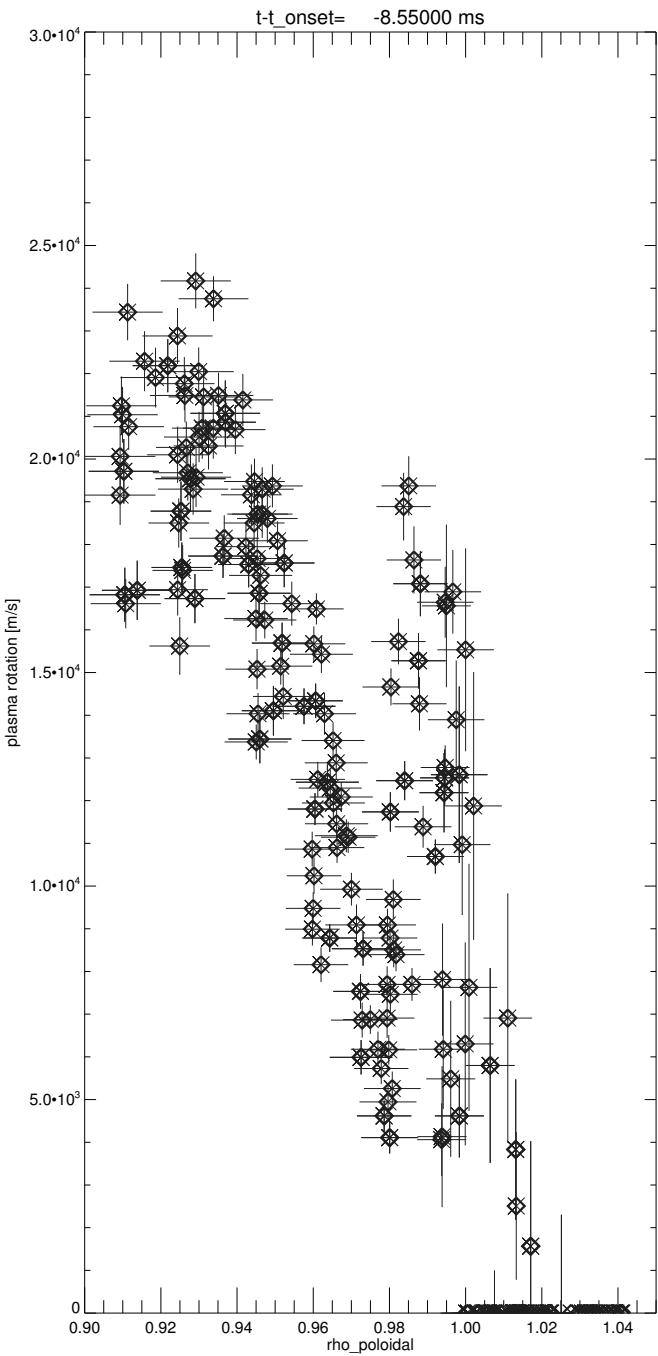
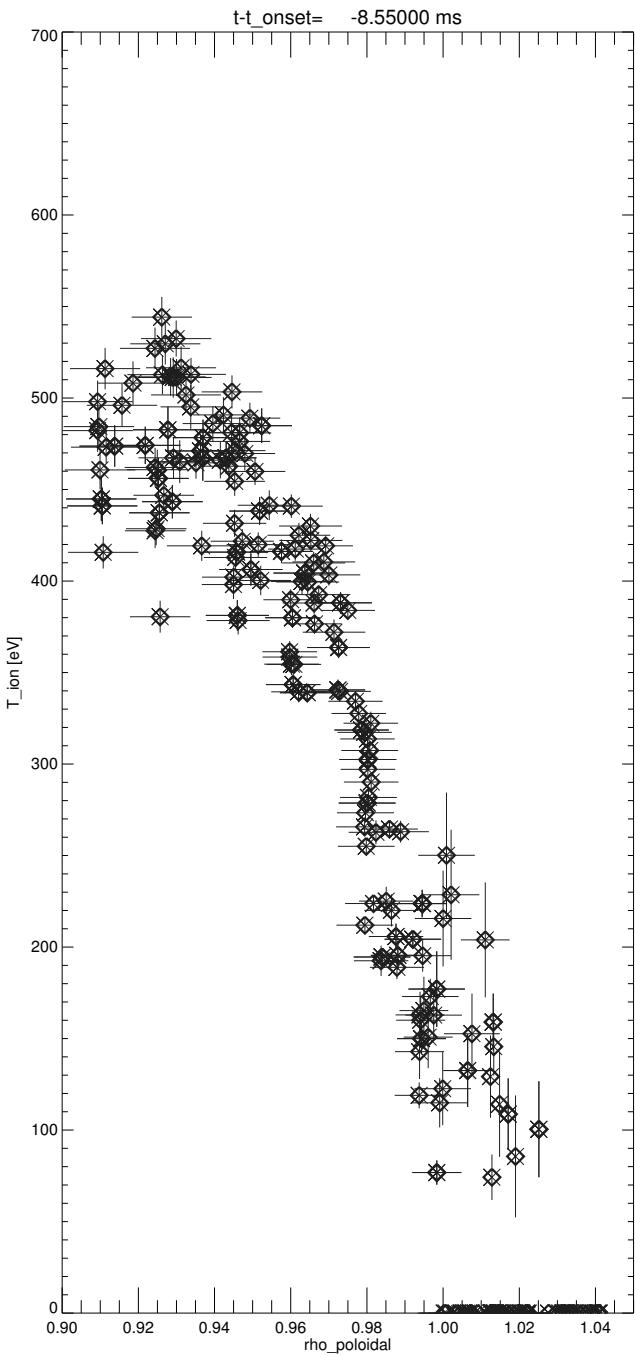
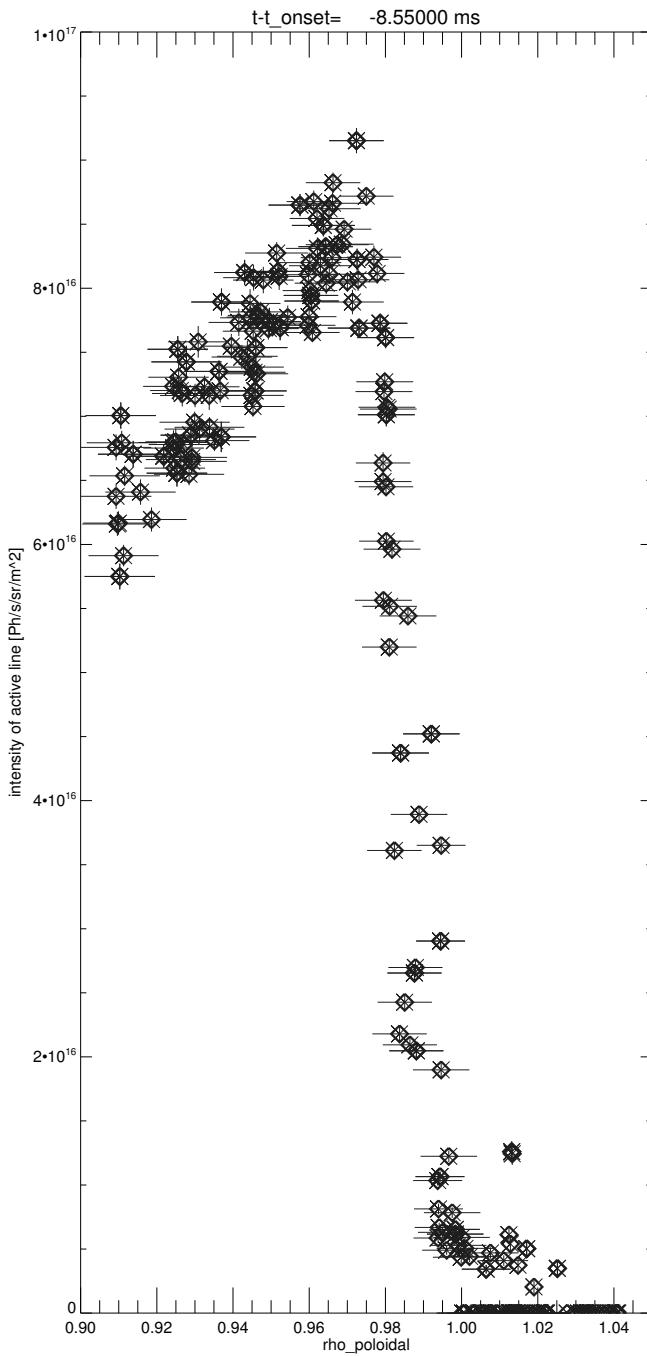


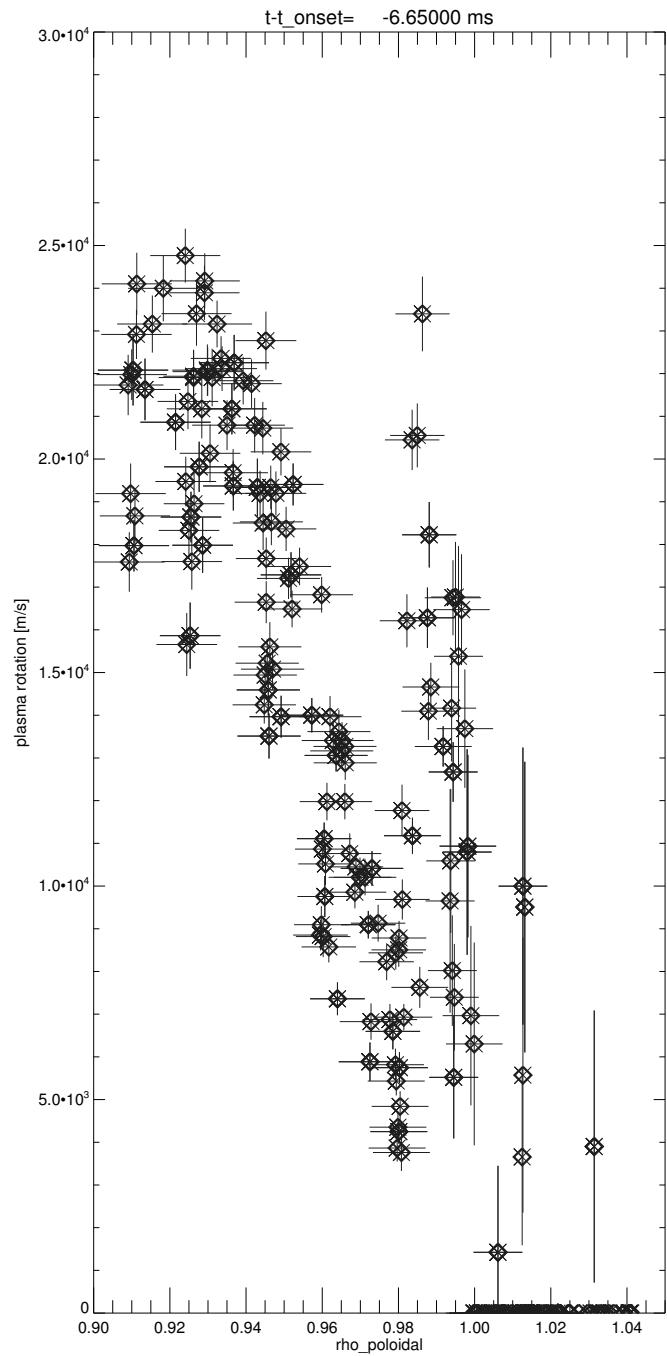
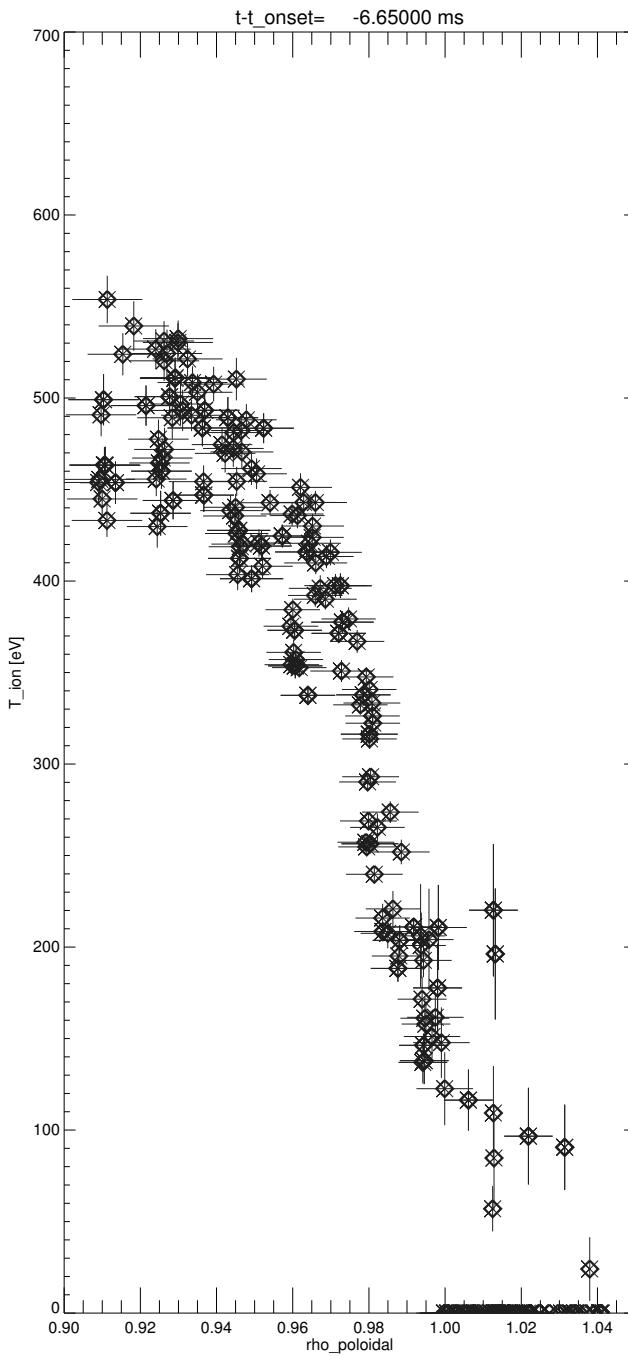
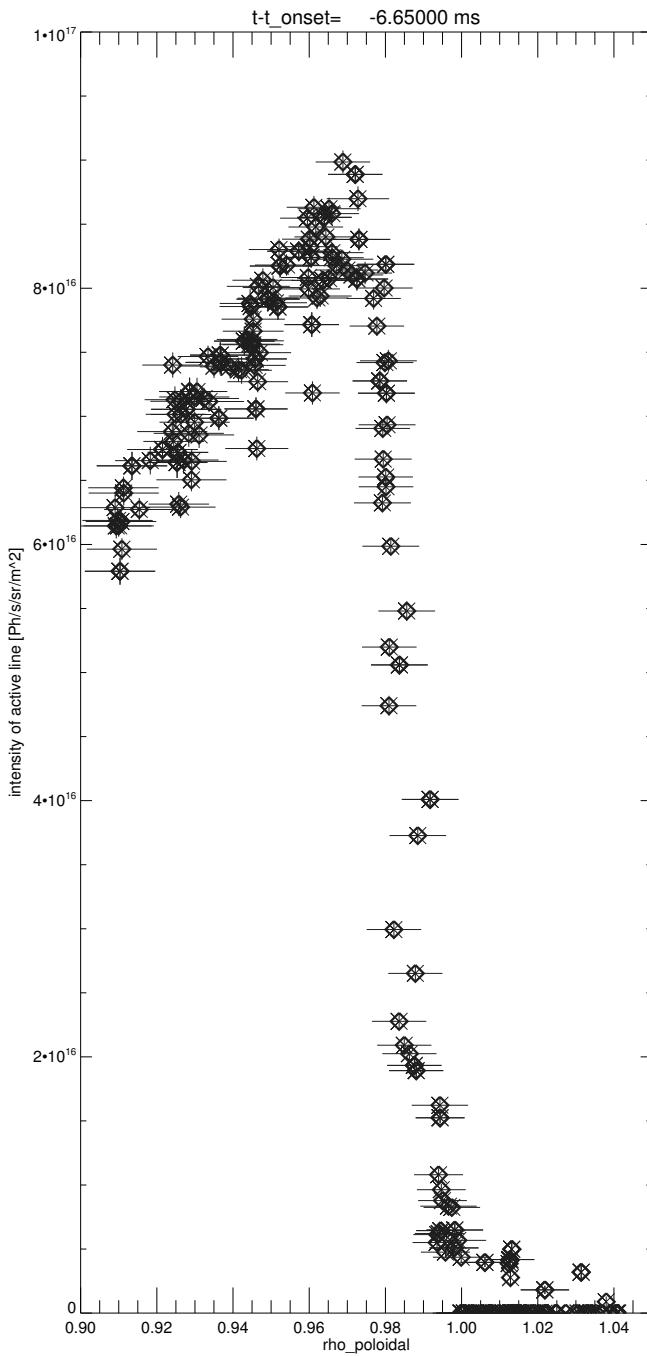


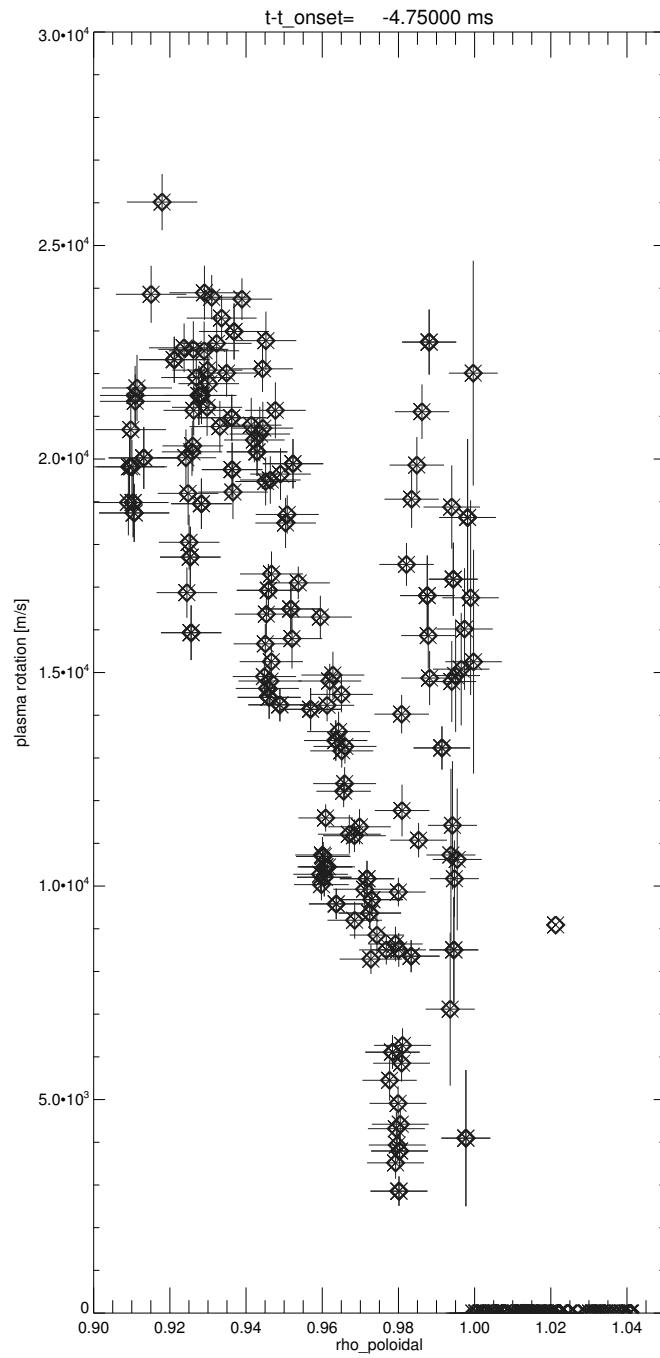
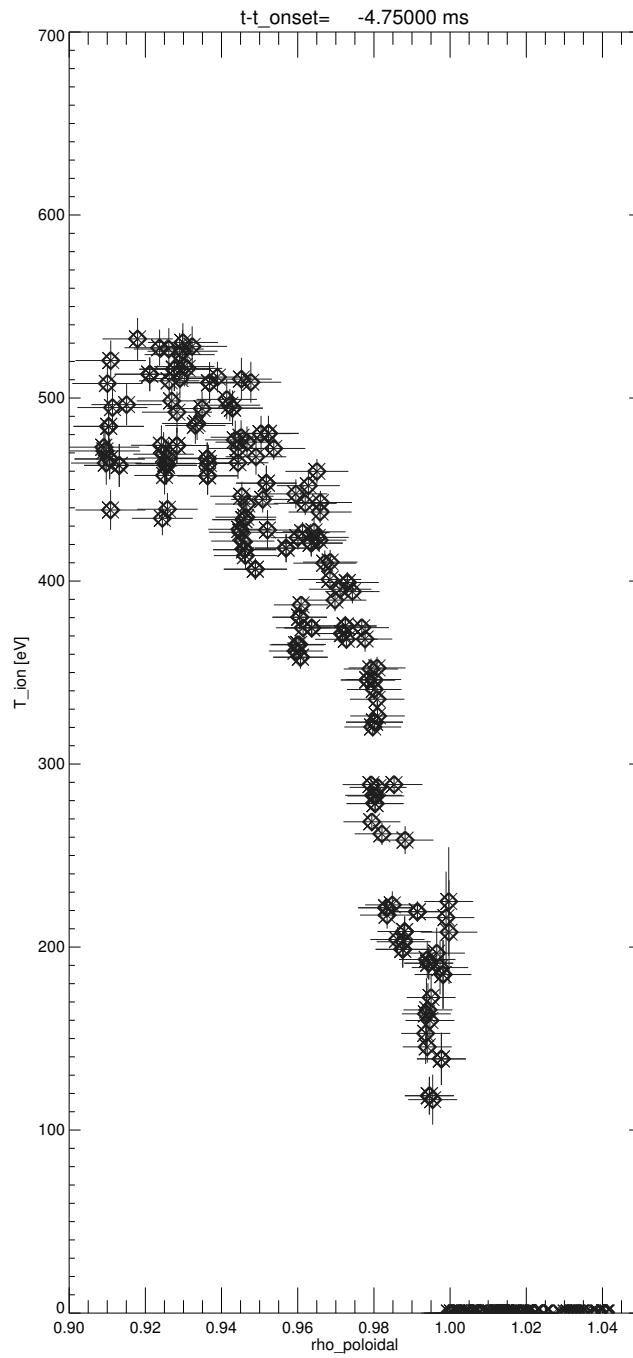
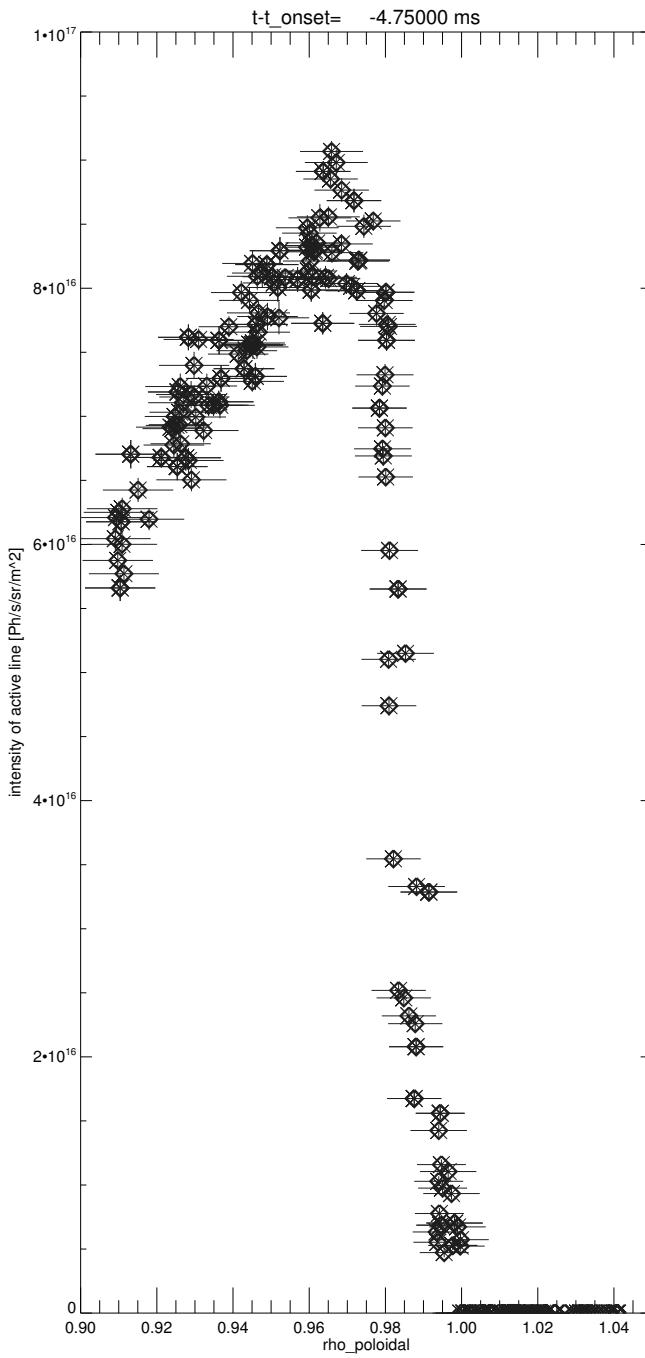


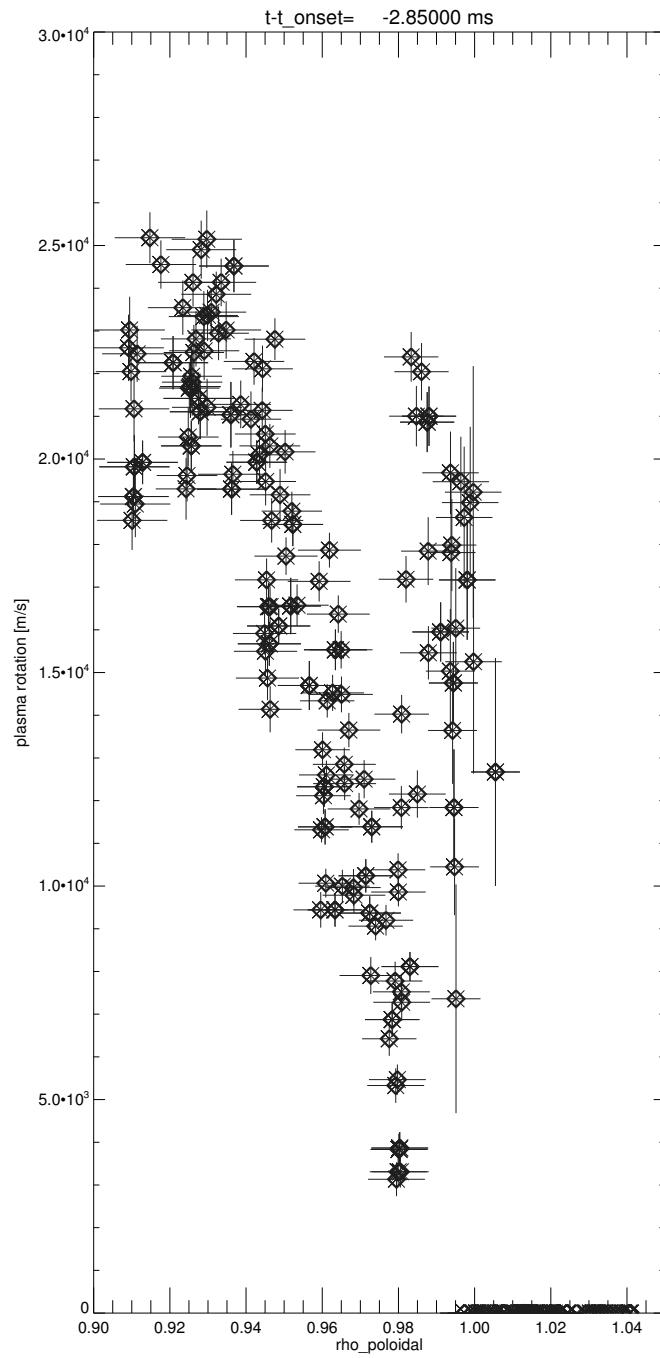
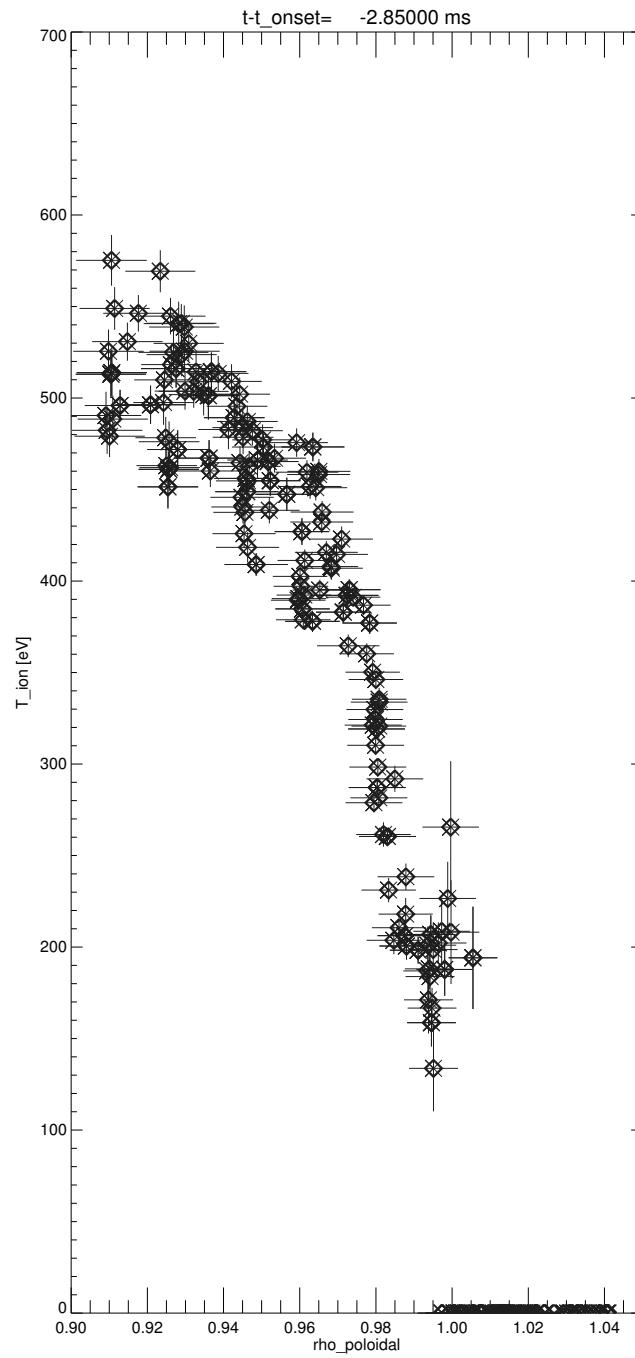
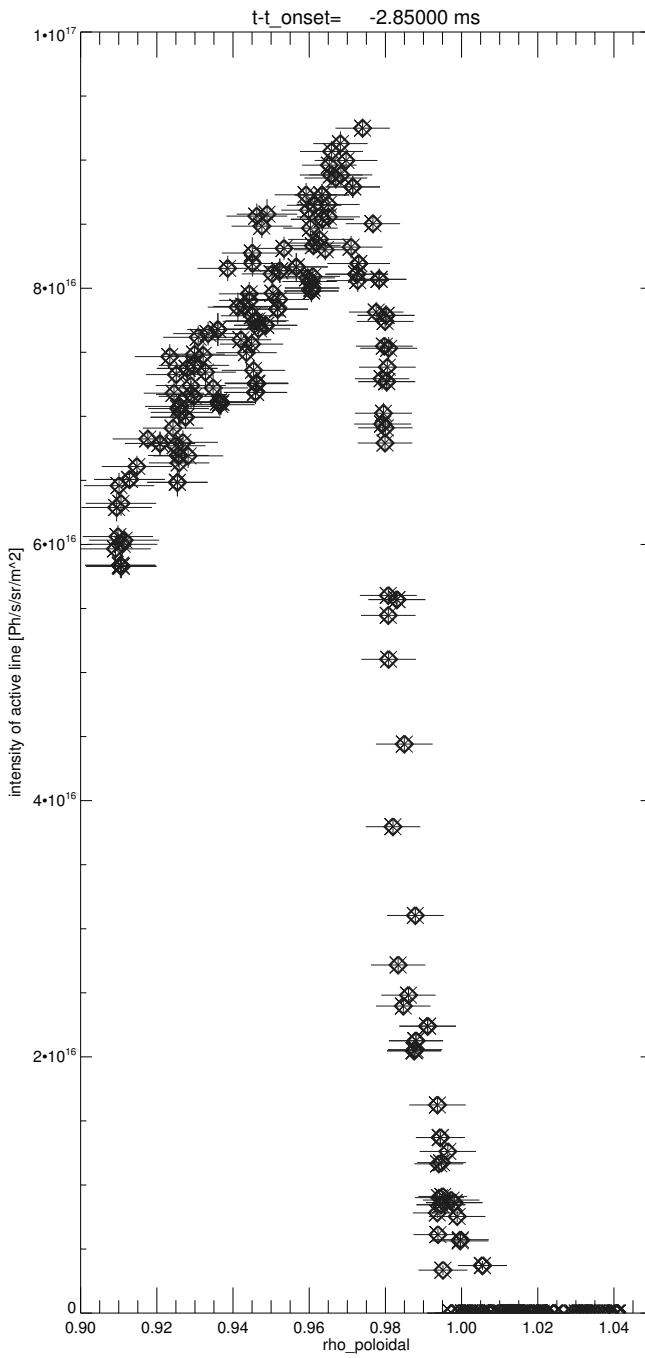


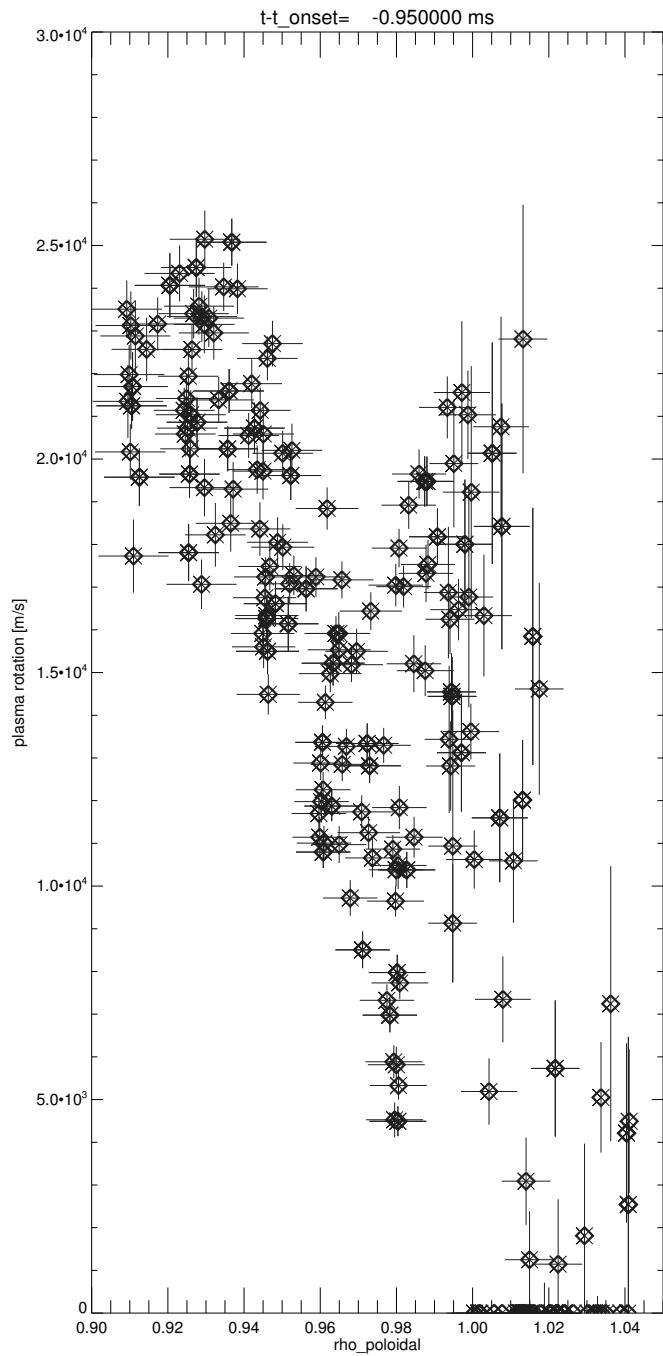
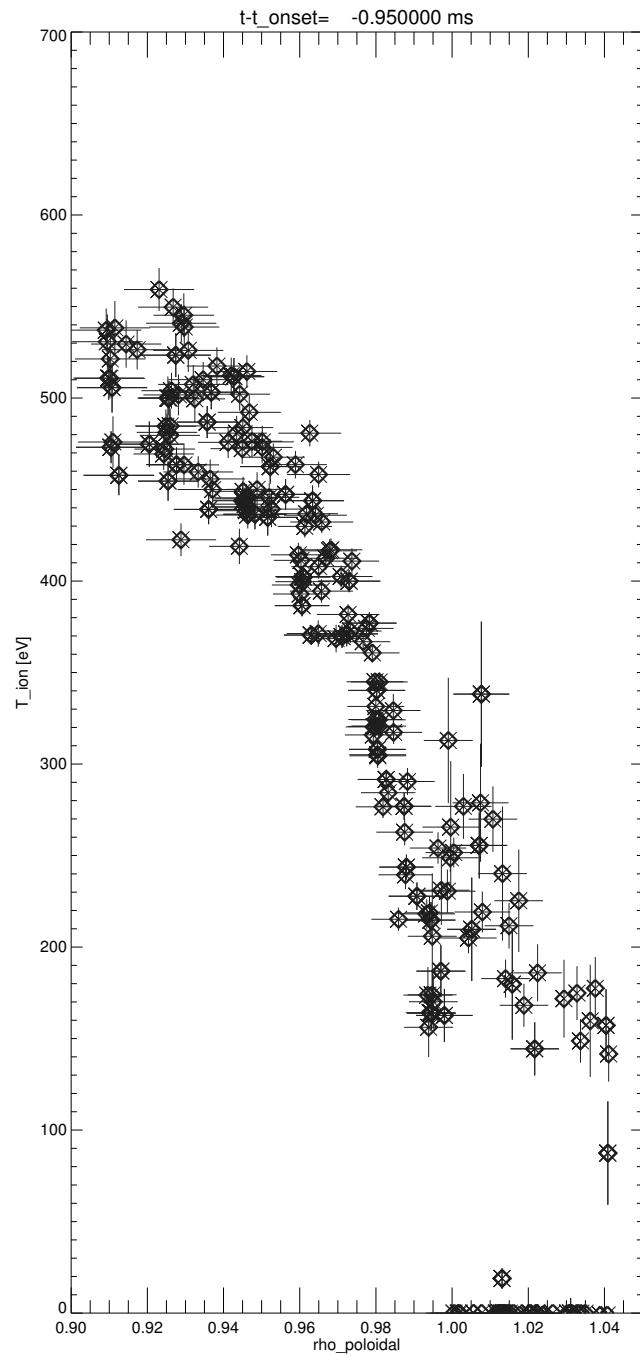
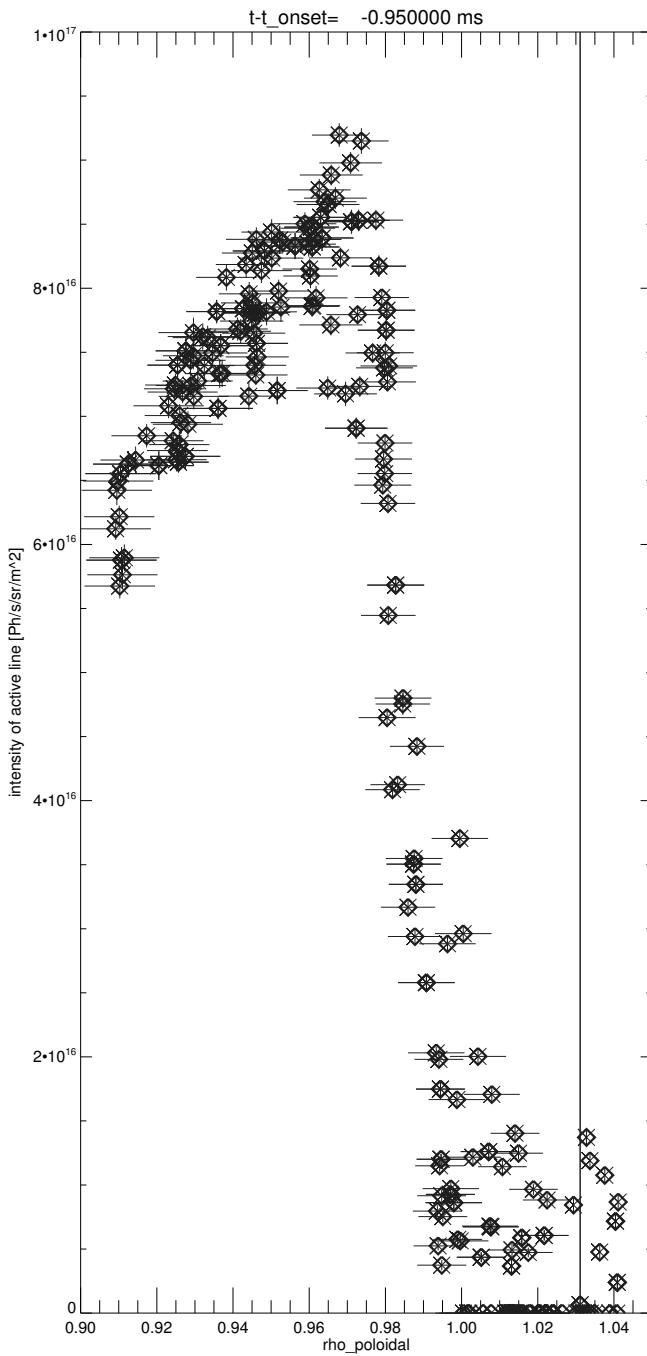


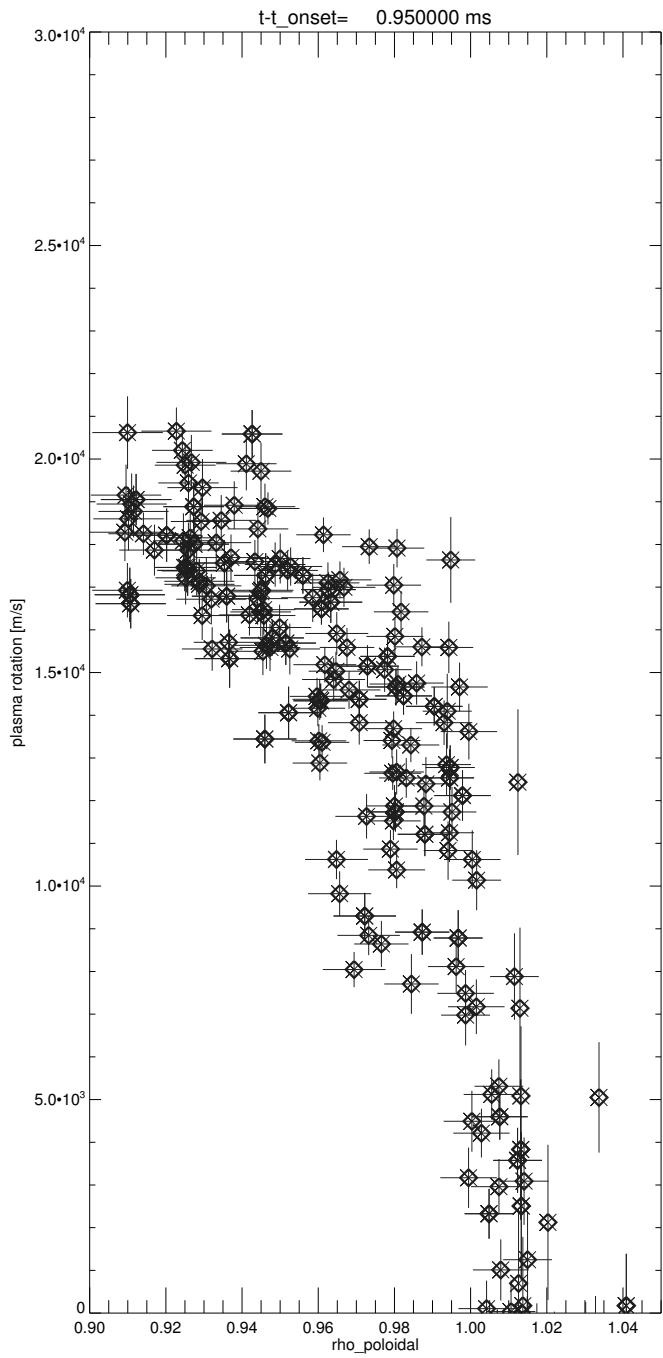
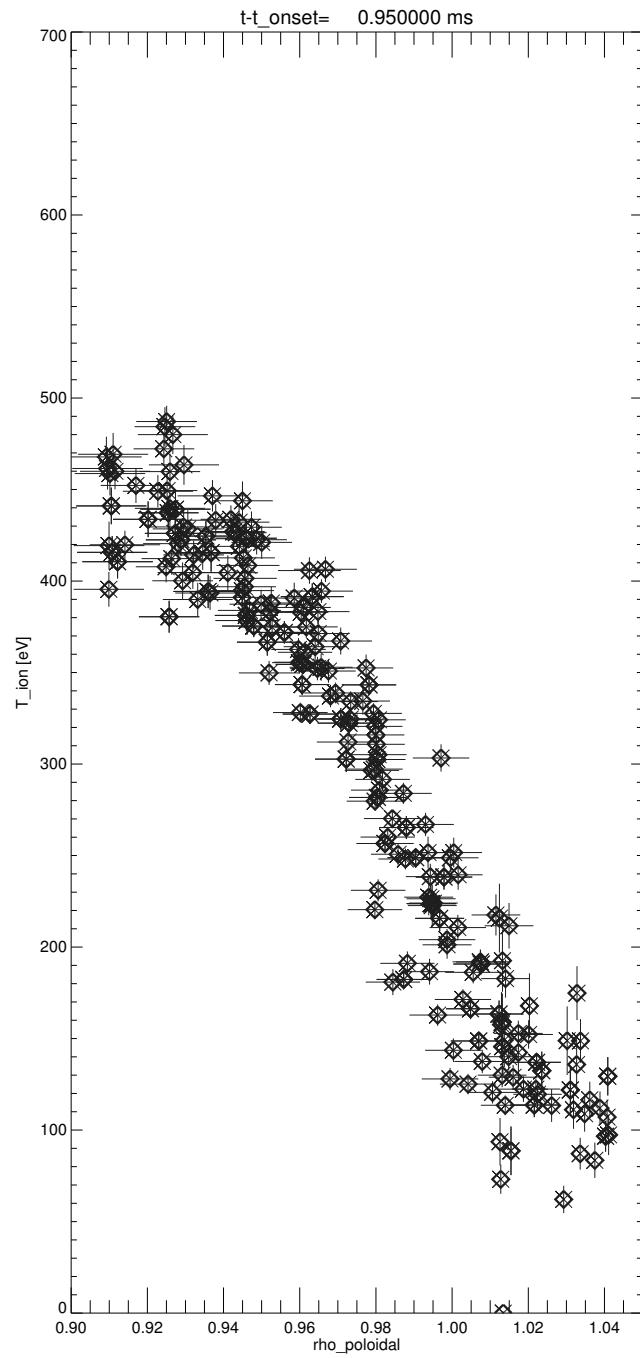
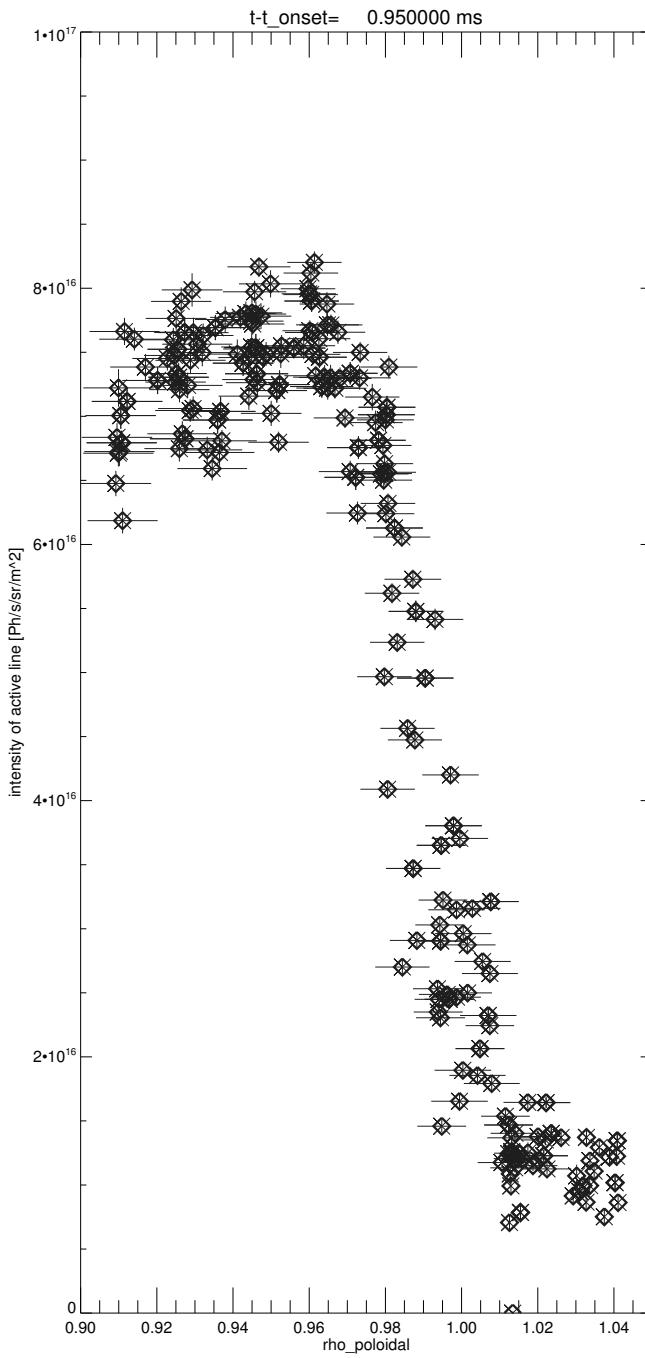


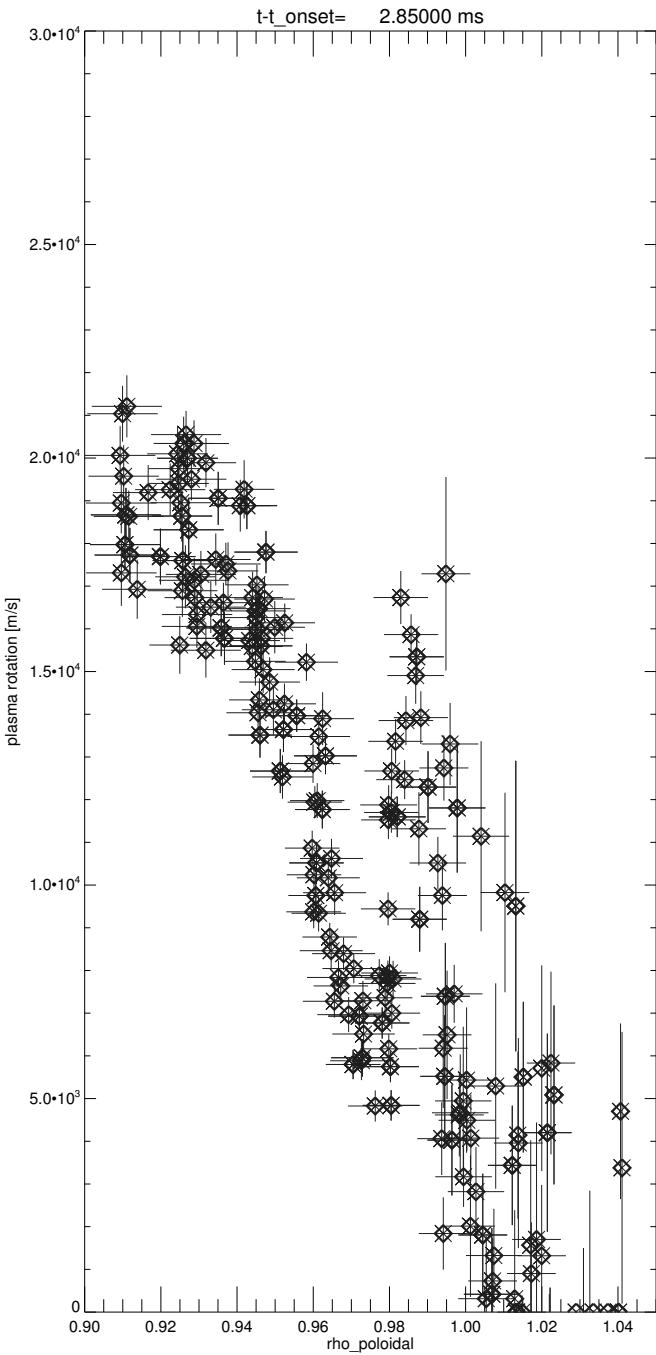
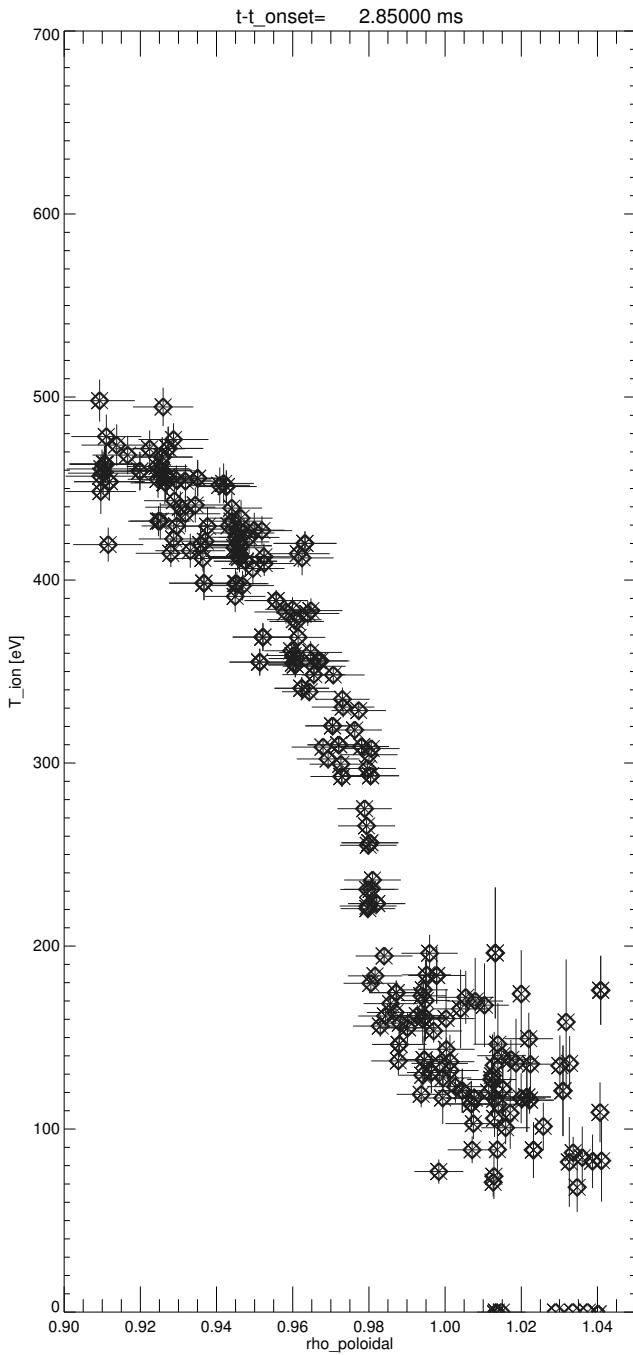
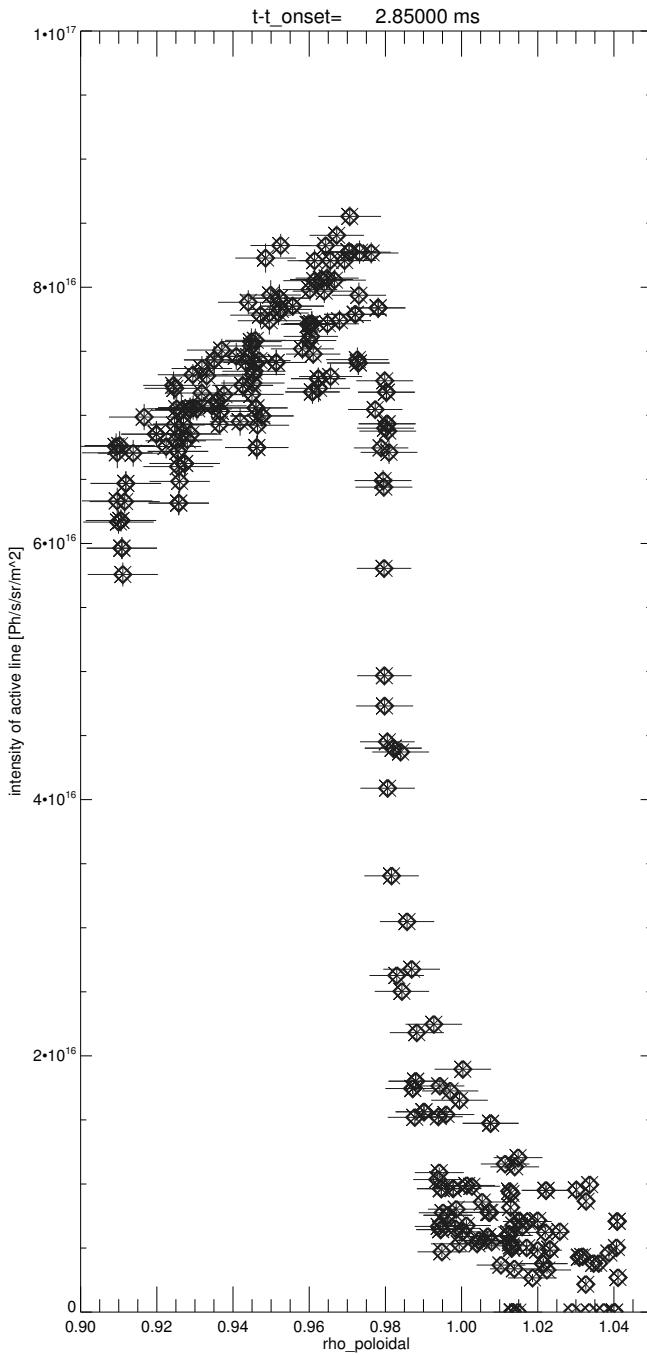


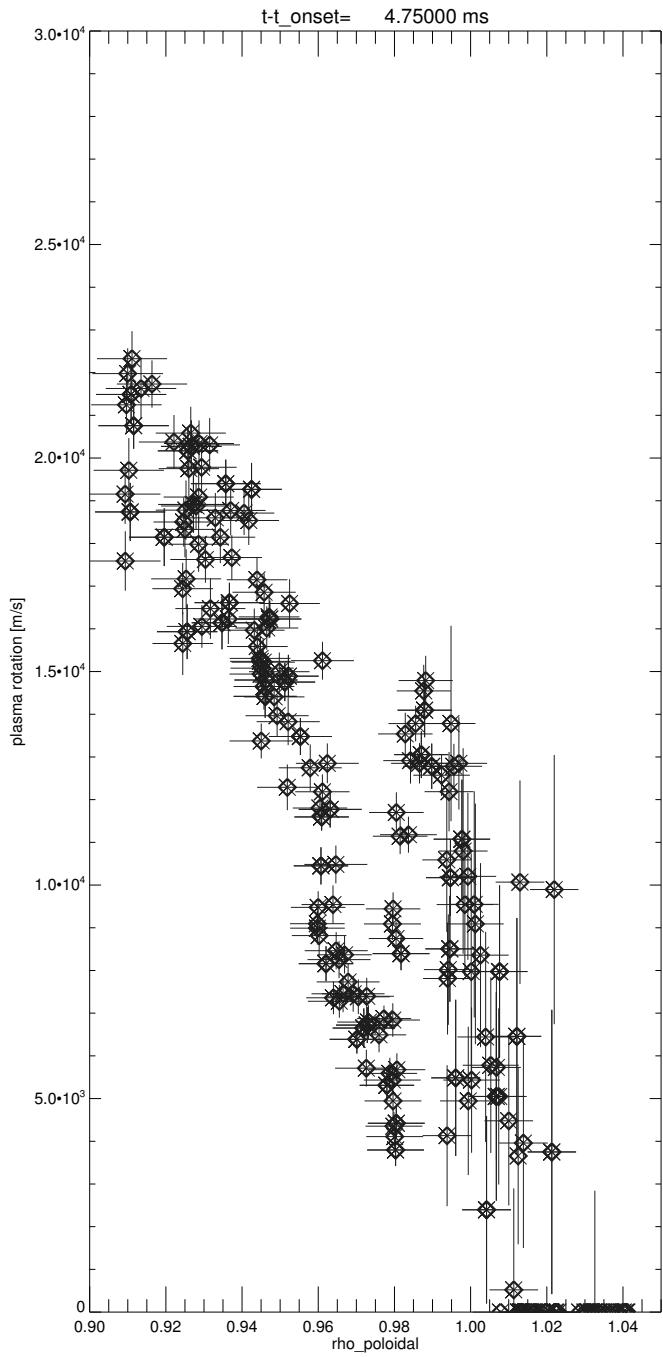
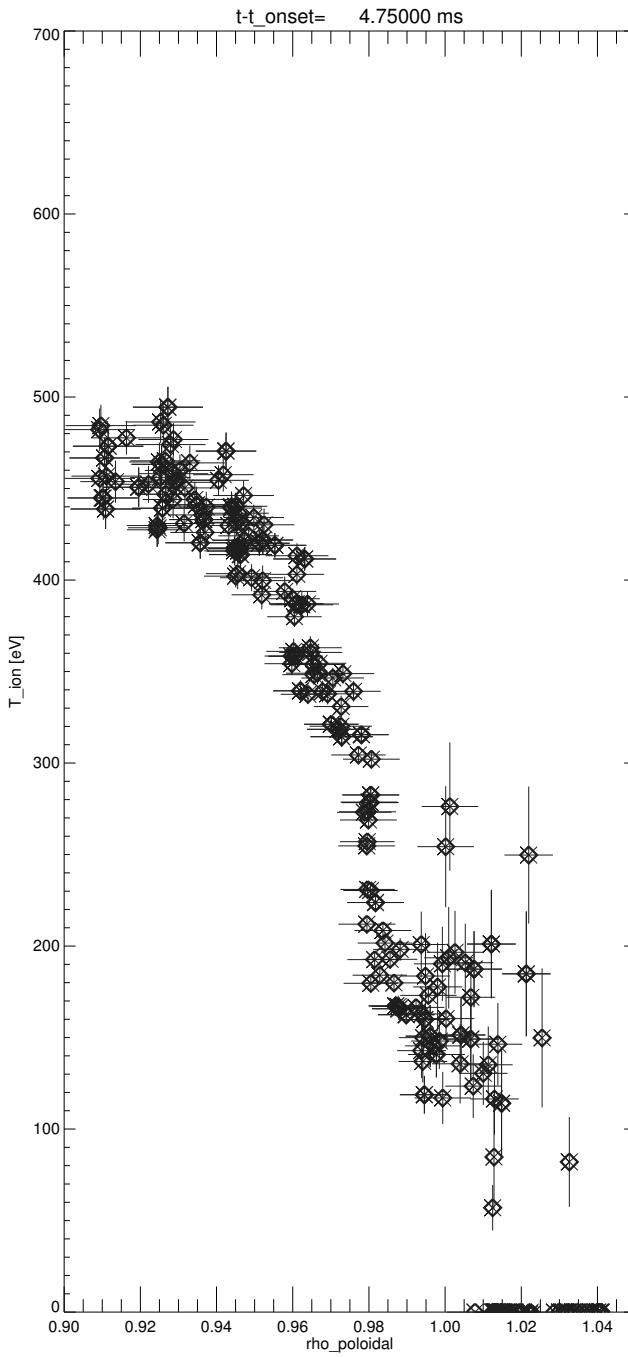
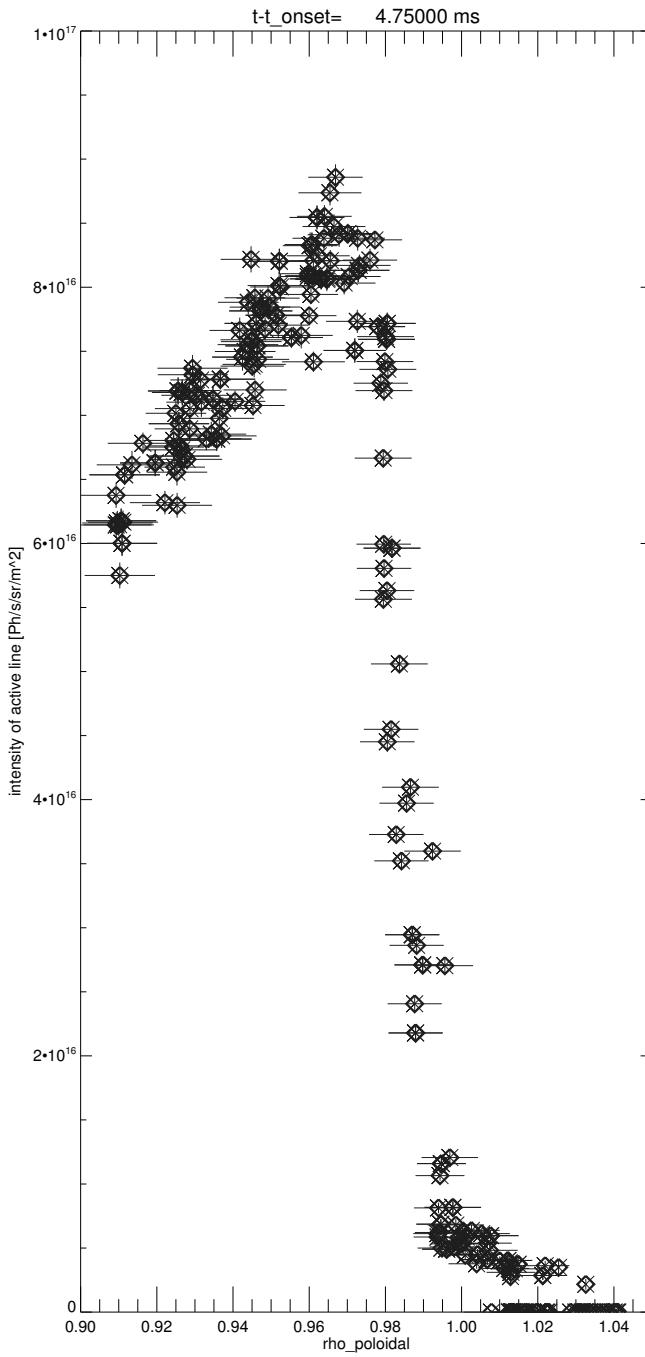


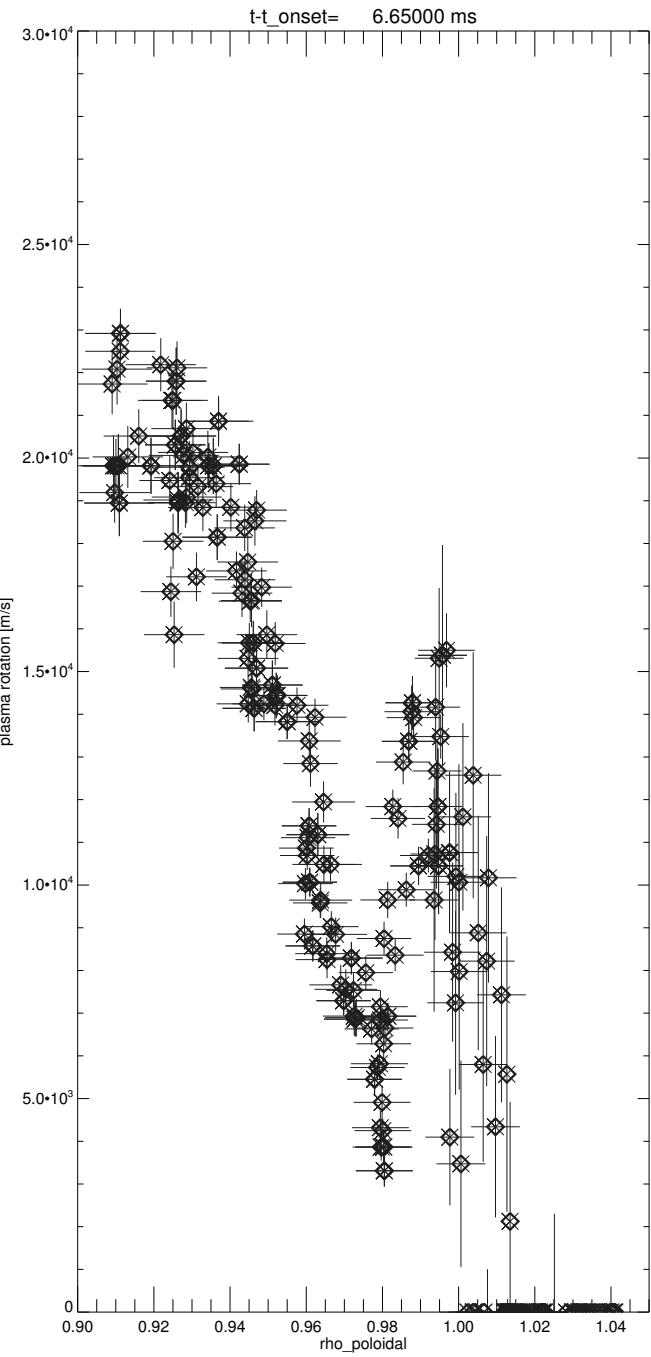
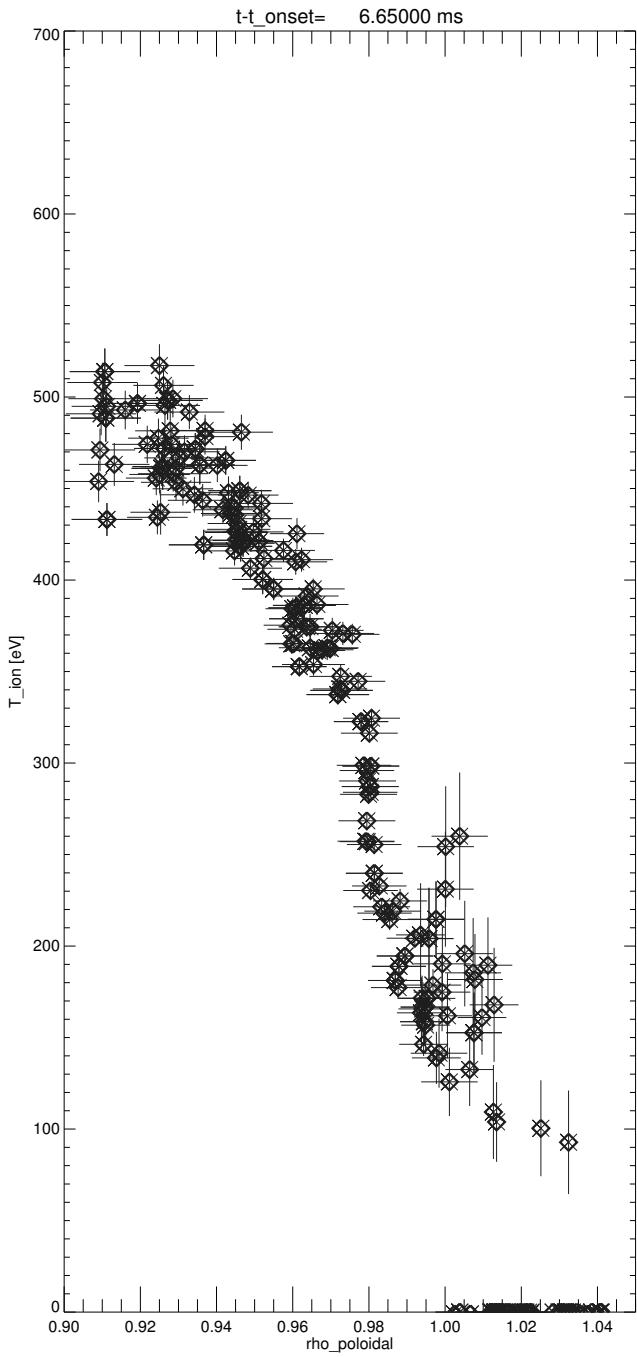
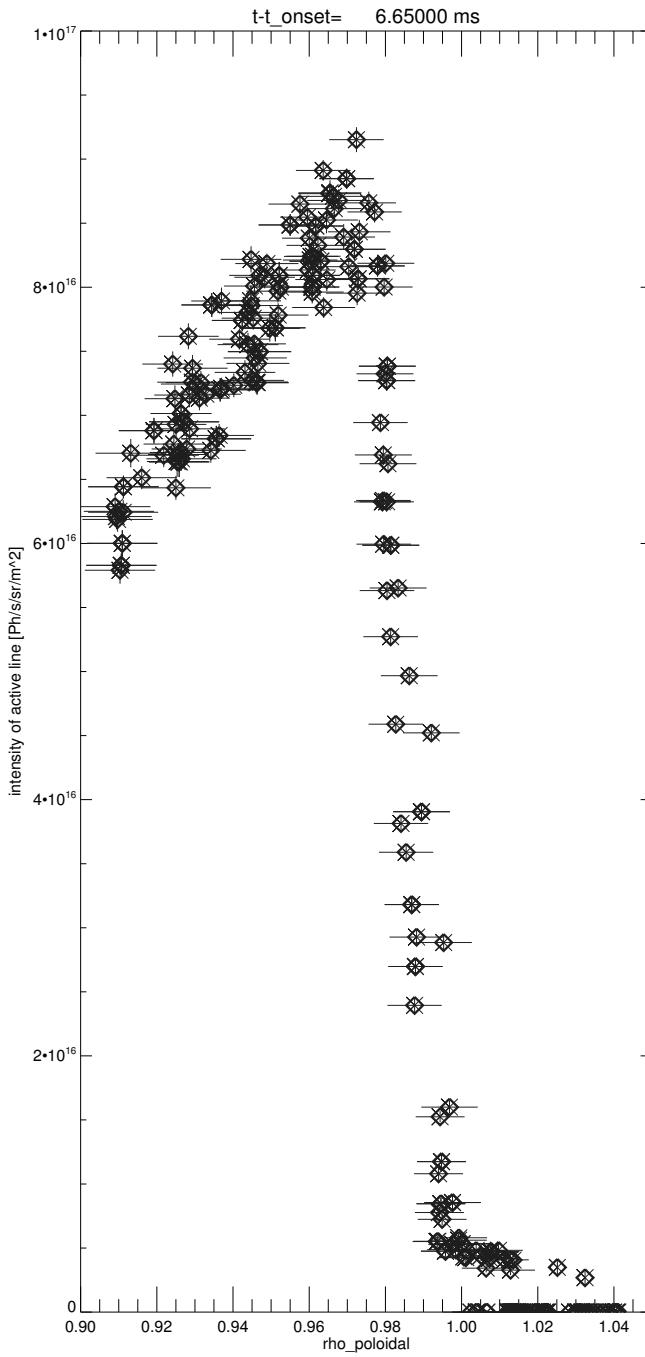


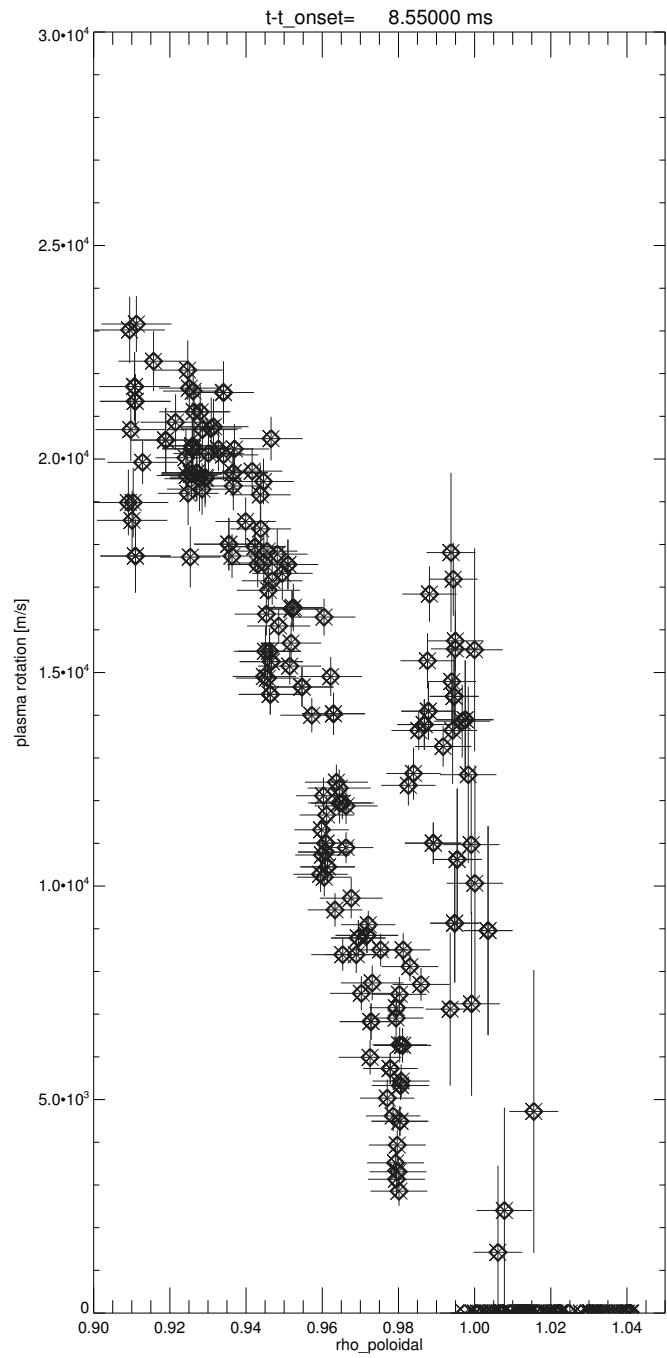
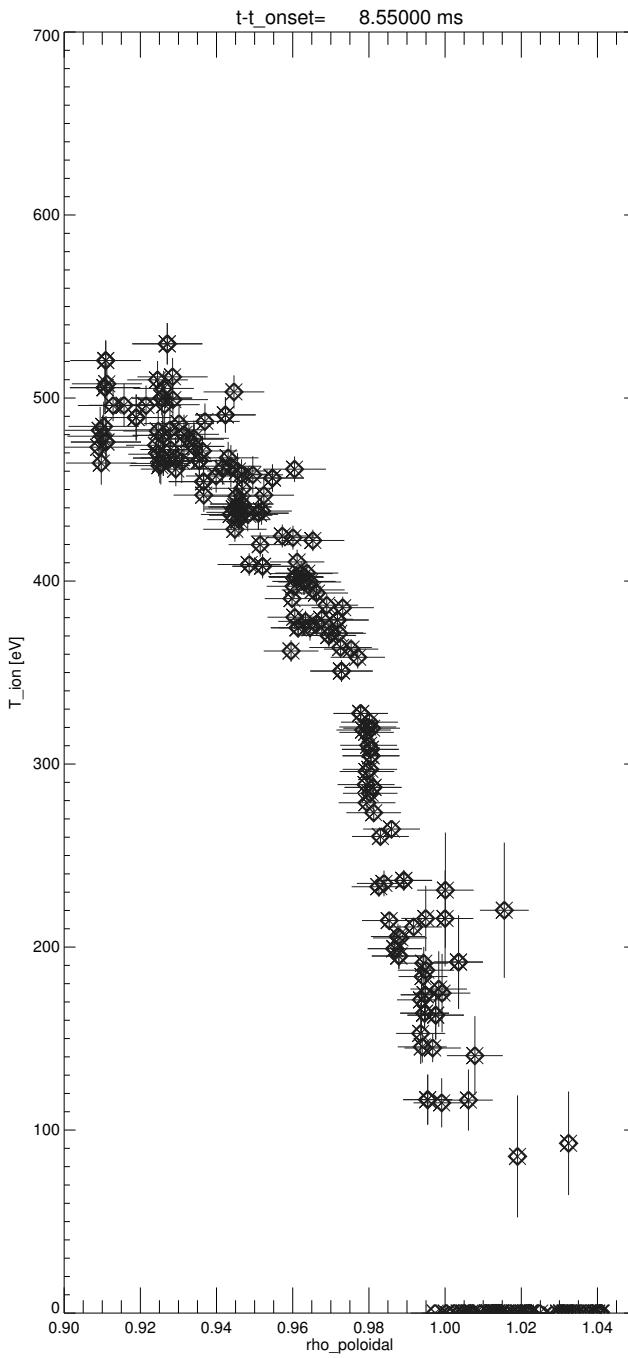
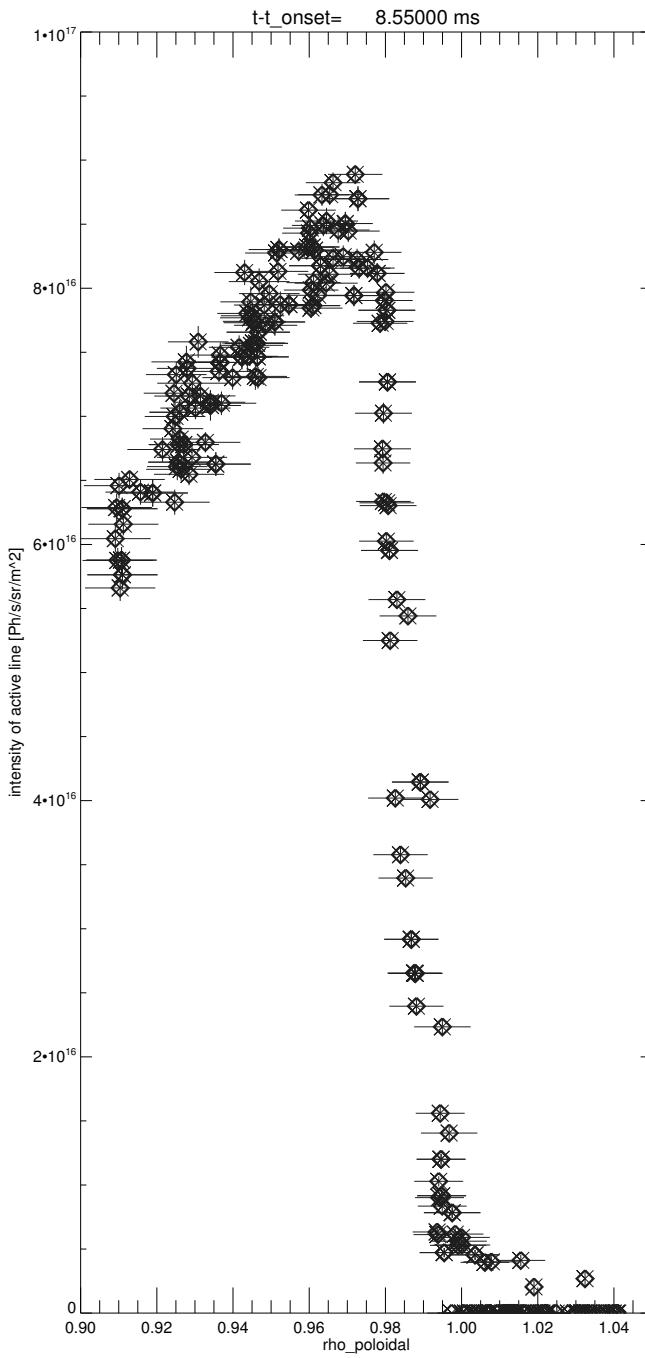


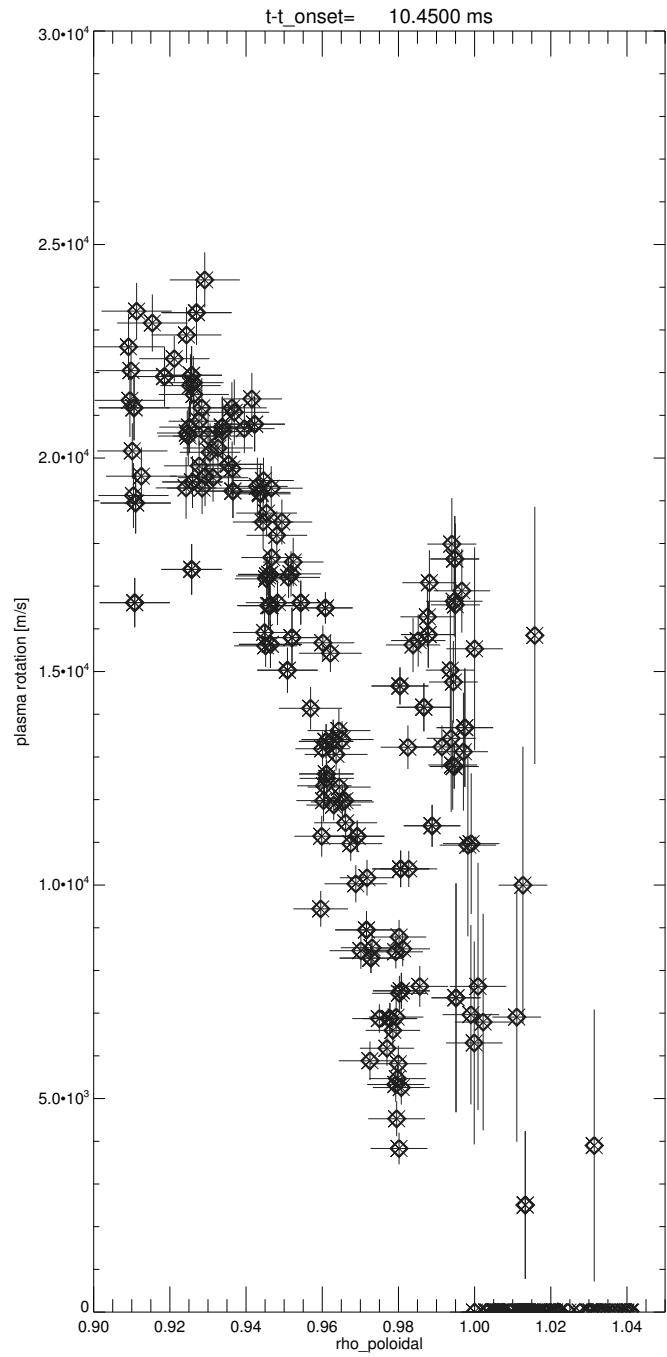
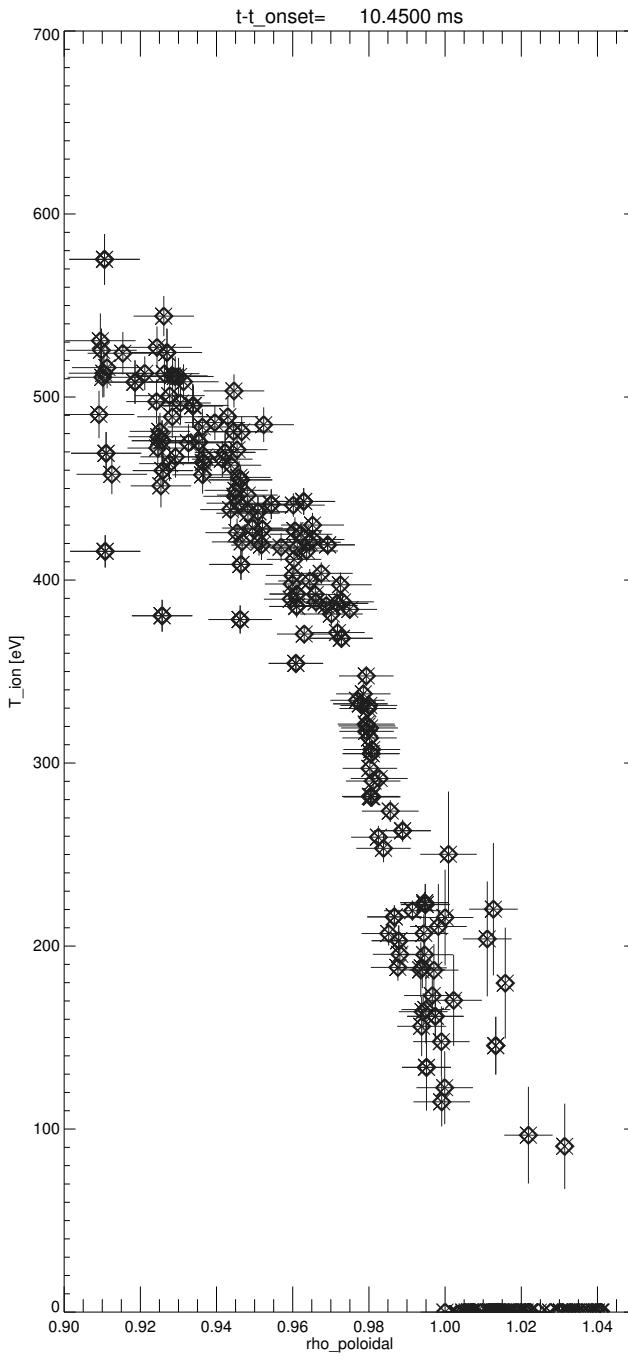
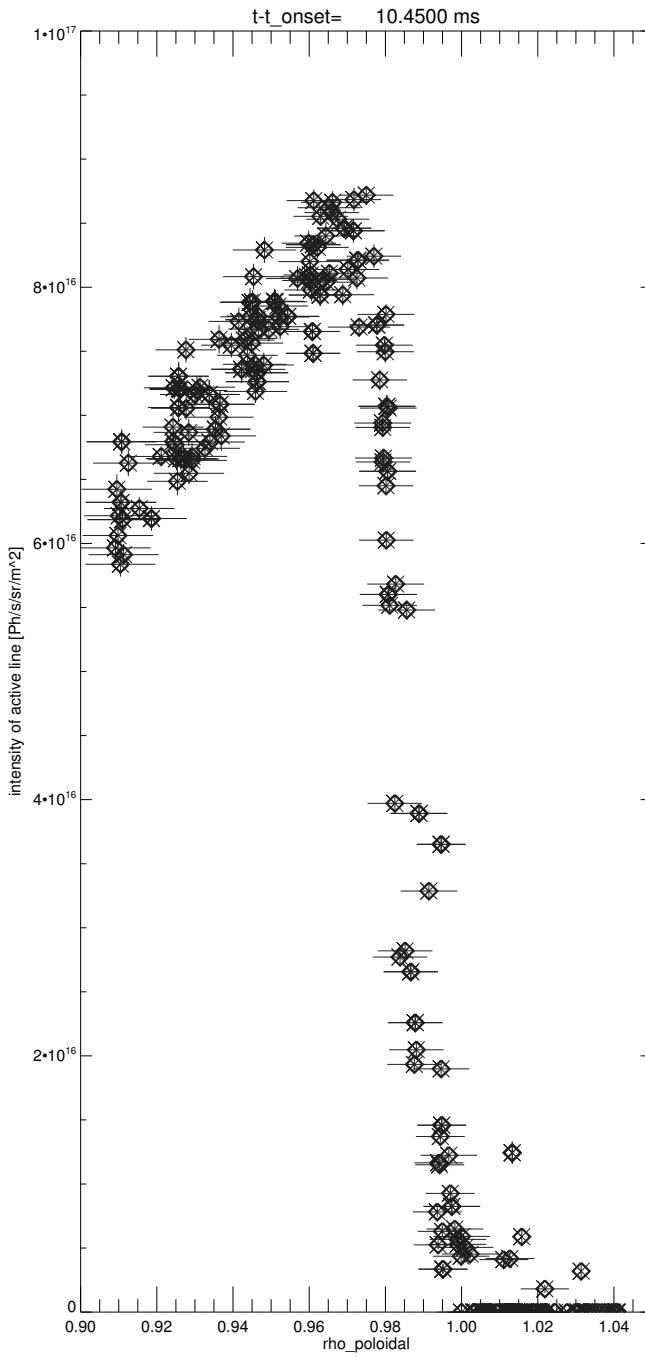












- new edge-CXRS diagnostic at ASDEX Upgrade
 - Fast measurements (1.9 ms) routinely available, high spatial resolution ($< 1\text{ cm}$)
 - ELM-cycle resolution possible
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- Comparison between different impurities in detail
 - Analysis of transport
 - Support for evaluating radial electric field